PLATINUM-COPPER FUEL CELL CATALYST

BACKGROUND OF THE INVENTION

FIELD OF THE INVENTION

[0001] The present invention relates to compositions which are useful as catalysts in fuel cell electrodes (e.g., electrocatalysts) and other catalytic structures, and which comprise platinum and copper.

DESCRIPTION OF RELATED TECHNOLOGY

[0002] A fuel cell is an electrochemical device for directly converting the chemical energy generated from an oxidation-reduction reaction of a fuel such as hydrogen or hydrocarbon-based fuels and an oxidizer such as oxygen gas (in air) supplied thereto into a low-voltage direct current. Thus, fuel cells chemically combine the molecules of a fuel and an oxidizer without burning, dispensing with the inefficiencies and pollution of traditional combustion.

[0003] A fuel cell is generally comprised of a fuel electrode (anode), an oxidizer electrode (cathode), an electrolyte interposed between the electrodes (alkaline or acidic), and means for separately supplying a stream of fuel and a stream of oxidizer to the anode and the cathode, respectively. In operation, fuel supplied to the anode is oxidized, releasing electrons that are conducted via an external circuit to the cathode. At the cathode, the supplied electrons are consumed when the oxidizer is reduced. The current flowing through the external circuit can be made to do useful work.

[0004] There are several types of fuel cells, including those having electrolytes of phosphoric acid, molten carbonate, solid oxide, potassium hydroxide, or a proton exchange membrane. A phosphoric acid fuel cell operates at about 160-220 °C, and preferably at about 190-200 °C. This type of fuel cell is currently being used for multi-megawatt utility power generation and for co-generation systems (i.e., combined heat and power generation) in the 50 to several hundred kilowatts range.

[0005] In contrast, proton exchange membrane fuel cells use a solid proton-conducting polymer membrane as the electrolyte. Typically, the polymer membrane is maintained in a hydrated form during operation in order to prevent loss of ionic conduction which limits the operation temperature typically to between about 70 and about 120°C, depending on the operating pressure, and

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preferably below about 100 °C. Proton exchange membrane fuel cells have a much higher power density than liquid electrolyte fuel cells (e.g., phosphoric acid), and can vary output quickly to meet shifts in power demand. Thus, they are suited for applications such as in automobiles and small-scale residential power generation where quick startup is a consideration.

[0006] In some applications (e.g., automotive) pure hydrogen gas is the optimum fuel; however, in other applications where a lower operational cost is desirable, a reformed hydrogen-containing gas is an appropriate fuel. A reformed hydrogen-containing gas is produced, for example, by steam-reforming methanol and water at 200-300 °C to a hydrogen-rich fuel gas containing carbon dioxide. Theoretically, the reformate gas consists of 75 vol% hydrogen and 25 vol% carbon dioxide. In practice, however, this gas also contains nitrogen, oxygen and, depending on the degree of purity, varying amounts of carbon monoxide (up to 1 vol%). Although some electronic devices also reform liquid fuel to hydrogen, in some applications the conversion of a liquid fuel directly into electricity is desirable, as then high storage density and system simplicity are combined. In particular, methanol is an especially desirable fuel because it has a high energy density, a low cost, and is produced from renewable resources.

[0007] For the oxidation and reduction reactions in a fuel cell to proceed at useful rates, especially at operating temperatures below about 300 °C, electrocatalyst materials are typically provided at the electrodes. Initially, fuel cells used electrocatalysts made of a single metal, usually platinum (Pt), palladium (Pd), rhodium (Rh), iridium (Ir), osmium (Os), silver (Ag) or gold (Au), because they are able to withstand the corrosive environment. In general, platinum is considered to be the most efficient and stable single-metal electrocatalyst for fuel cells operating below about 300 °C.

[0008] While the above-noted elements were first used in fuel cells in metallic powder form, later techniques were developed to disperse these metals over the surface of electrically conductive supports (e.g., carbon black) to increase the surface area of the electrocatalyst. An increase in the surface area of the electrocatalyst in turn increases the number of reactive sites, leading to improved efficiency of the cell. Nevertheless, fuel cell performance typically declines over time because the presence of electrolyte, high temperatures and molecular oxygen dissolve the electrocatalyst and/or sinter the dispersed electrocatalyst by surface migration or dissolution/re-precipitation.

[0009] Although platinum is considered to be the most efficient and stable single-metal electrocatalyst for fuel cells, it is costly. Additionally, an increase in electrocatalyst activity over platinum is desirable, if not necessary,

for wide-scale commercialization of fuel cell technology. However, the development of cathode fuel cell electrocatalyst materials faces longstanding challenges. The greatest challenge is the improvement of the electrode kinetics of the oxygen reduction reaction. In fact, sluggish electrochemical reaction kinetics has prevented electrocatalysts from attaining the thermodynamic

- 5 kinetics has prevented electrocatalysts from attaining the thermodynamic reversible electrode potential for oxygen reduction. This is reflected in exchange current densities of around 10⁻¹⁰ to 10⁻¹² A/cm² for oxygen reduction on, for example, Pt at low and medium temperatures. A factor contributing to this phenomenon includes the fact that the desired reduction of oxygen to water is a 10 four-electron transfer reaction and typically involves breaking a strong O-O bond early in the reaction. In addition, the open circuit voltage is lowered from the thermodynamic potential for oxygen reduction due to the formation of peroxide and possible platinum oxides that inhibit the reaction. A second challenge is the stability of the oxygen electrode (cathode) during long-term operation.
- 15 Specifically, a fuel cell cathode operates in a regime in which even the most unreactive metals are not completely stable. Thus, alloy compositions that contain non-noble metal elements may have a rate of corrosion that would negatively impact the projected lifetime of a fuel cell. Corrosion may be more severe when the cell is operating near open circuit conditions - the most 20 desirable potential for thermodynamic efficiency.
- [0010] Electrocatalyst materials at the anode also face challenges during fuel cell operation. Specifically, as the concentration of carbon monoxide (CO) rises above about 10 ppm in the fuel the surface of the electrocatalyst can be rapidly poisoned. As a result, platinum (by itself) is a poor electrocatalyst if the fuel stream contains carbon monoxide (e.g., reformed-hydrogen gas typically exceeds 100 ppm). Liquid hydrocarbon-based fuels (e.g., methanol) present an even greater poisoning problem. Specifically, the surface of the platinum becomes blocked with the adsorbed intermediate, carbon monoxide (CO). It has been reported that H₂O plays a key role in the removal of such poisoning species in accordance with the following reactions:

Pt +
$$CH_3OH \rightarrow Pt—CO + 4H^+ + 4e^-$$
 (1);

$$Pt_1 + H_2O - Pt - OH + H^+ + e^-$$
 (2); and

$$Pt-CO + Pt-OH - 2Pt + CO_2 + H^+ + e^-$$
 (3).

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As indicated by the foregoing reactions, the methanol is adsorbed and partially oxidized by platinum on the surface of the electrode (1). Adsorbed OH, from the hydrolysis of water, reacts with the adsorbed CO to produce carbon dioxide and a proton (2,3). However, platinum does not form OH species rapidly at the potentials where fuel cell electrodes operate (e.g., 200 mV-1.5 V). As a result, step (3) is the slowest step in the sequence, limiting the rate of CO removal, thereby allowing poisoning of the electrocatalyst to occur. This applies in particular to a proton exchange membrane fuel cell which is especially sensitive to CO poisoning because of its low operating temperatures.

[0011] One approach for improving the cathodic performance of an electrocatalyst during the reduction of oxygen and/or the anodic performance during the oxidation of hydrogen or methanol is to employ an electrocatalyst which is more active, corrosion resistant, and/or more poison tolerant. For example, increased tolerance to CO has been reported by alloying platinum and ruthenium at a 50:50 atomic ratio (see, D. Chu and S. Gillman, J. Electrochem. Soc. 1996, 143, 1685). The electrocatalysts proposed to-date, however, leave room for further improvement.

BRIEF SUMMARY OF THE INVENTION

[0012] Briefly, therefore, the present invention is directed to a composition for use as a catalyst in oxidation or reduction reactions, in for example fuel cells, the composition comprising platinum and copper, wherein (i) the concentration of platinum is greater than 50 atomic percent and less than about 80 atomic percent, and (ii) the composition has a particle size which is less than 35 angstroms (Å).

[0013] The present invention is further directed to the preceding composition wherein the sum of the concentrations of platinum and copper therein is greater than about 95 atomic percent.

[0014] The present invention is still further directed to one of the preceding compositions wherein said composition comprises an alloy of the recited metals, or alternatively consists essentially of an alloy of the recited metals.

[0015] The present invention is still further directed to a supported electrocatalyst powder for use in electrochemical reactor devices, the supported electrocatalyst powder comprising any of the foregoing catalyst compositions on electrically conductive support particles.

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[0016] The present invention is also directed to a fuel cell electrode, the fuel cell electrode comprising electrocatalyst particles and an electrode substrate upon which the electrocatalyst particles are deposited, the electrocatalyst particles comprising any of the foregoing catalyst compositions.

[0017] The present invention is also directed to a fuel cell comprising an anode, a cathode, a proton exchange membrane between the anode and the cathode, and any of the foregoing catalyst compositions, for the catalytic oxidation of a hydrogen-containing fuel or the catalytic reduction of oxygen.

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[0018] The present invention is further directed to a method for the electrochemical conversion of a hydrogen-containing fuel and oxygen to reaction products and electricity in the foregoing fuel cell, said fuel cell further comprising an electrically conductive external circuit connecting the anode and cathode. The method comprises contacting the hydrogen-containing fuel or the oxygen and the catalyst composition to catalytically oxidize the hydrogen-containing fuel or catalytically reduce the oxygen.

[0019] The present invention is still further directed to a fuel cell electrolyte membrane, and/or fuel cell electrode, having deposited on a surface thereof a layer of an unsupported catalyst composition, said unsupported catalyst composition layer comprising any of the foregoing catalyst compositions.

[0020] The present invention is still further directed to a method for preparing one of the foregoing catalyst compositions from a catalyst precursor composition, said precursor composition comprising platinum and copper, wherein the concentration of platinum therein is greater than about 20 atomic percent and less than about 40 atomic percent. The method comprises subjecting said precursor composition to conditions sufficient to remove a portion of the copper present therein, such that the resulting catalyst composition comprises platinum and copper, and wherein the concentration of platinum is greater than 50 atomic percent and less than about 80 atomic percent. Optionally, the catalyst composition may have a particle size which is less than 35 angstroms (Å).

[0021] The present invention is further directed to such a method wherein the catalyst precursor composition is contacted with an acidic solution to solubilize a portion of the copper present therein. Alternatively, the present invention is further directed to such a method wherein the catalyst precursor composition is subjected to an electrochemical reaction, wherein for example a hydrogen-containing fuel and oxygen are converted to reaction products and electricity in a fuel cell comprising an anode, a cathode, a proton exchange

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membrane therebetween, the catalyst precursor composition, and an electrically conductive external circuit connecting the anode and cathode. By contacting the hydrogen-containing fuel or the oxygen and the catalyst precursor composition, the hydrogen-containing fuel is oxidized and/or the oxygen is catalytically reduced. As part of this reaction, copper is dissolved *in situ* from the catalyst precursor composition.

[0022] The present invention is still further directed to a method for preparing a catalyst composition from a catalyst precursor composition, said precursor composition comprising platinum and copper, wherein the concentration of platinum therein is less than 50 atomic percent. The method comprises contacting said precursor composition with an acidic solution having a pH which is greater than 0 and less than 7, to solubilize a portion of the copper present therein, such that the resulting catalyst composition comprises platinum and copper, the concentration of platinum therein being greater than 50 atomic percent. Optionally, the platinum concentration of the catalyst precursor may be greater than about 20 atomic percent and less than about 40 atomic percent, and/or the concentration of platinum in the catalyst composition may be greater than 50 atomic percent and less than about 80 atomic percent. Additionally, the catalyst composition may optionally have a particle size which is less than 35 angstroms (Å).

[0023] The present invention is still further directed to a method for preparing a catalyst composition from a catalyst precursor composition, said precursor composition comprising platinum and copper, wherein the concentration of platinum therein is less than 50 atomic percent. The method comprises contacting said precursor composition with a solution in air, or alternatively in an atmosphere having a oxygen concentration which is greater than in air, to solubilize a portion of the copper present therein, such that the resulting catalyst composition comprises platinum and copper, the concentration of platinum therein being greater than 50 atomic percent. Optionally, the platinum concentration of the catalyst precursor may be greater than about 20 atomic percent and less than about 40 atomic percent, and/or the concentration of platinum in the catalyst composition may be greater than 50 atomic percent and less than about 80 atomic percent. Additionally, the catalyst composition may optionally have a particle size which is less than 35 angstroms (Å).

[0024] The present invention is still further directed to a method of preparing a catalyst composition comprising, or consisting essentially of, an alloy of platinum and copper. The method comprises depositing a copper-containing compound, and optionally a platinum-containing compound, on electrically

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conductive support particles, and heating the copper and platinum on said support particles in a reducing atmosphere at a temperature which is greater than about 450°C and less than 800°C for a duration sufficient to form an alloy of copper and platinum, wherein the concentration of platinum in the catalyst composition is greater than about 50 atomic percent and less than about 80 atomic percent. Optionally, the copper and platinum alloy of the catalyst composition has a particle size which is less than 35 angstroms (Å).

[0025] The present invention is still further directed to a method of preparing a catalyst composition comprising an alloy of platinum and copper on electrically conductive support particles. The method comprises: (a) forming a catalyst composition precursor having a platinum concentration that is greater than about 20 atomic percent and less than about 40 atomic percent, by (i) depositing a copper-containing compound on electrically conductive support particles, (ii) depositing a platinum-containing compound on electrically conductive support particles, and (iii) heating said deposited compounds on said support particles in a reducing atmosphere at a temperature which is greater than about 450°C for a duration of at least 2 hours to form an alloy of copper and platinum; and, (b) contacting said precursor composition with an acidic solution in air, or alternatively in an atmosphere having an oxygen concentration which is greater than in air, to solubilize a portion of the copper present therein.

[0026] The present invention is further directed to one of the foregoing methods for preparing the catalyst composition wherein the sum of the concentrations of platinum and copper in the catalyst composition precursor, and/or the catalyst composition, is greater than about 95 atomic percent.

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[0027] It is to be understood that the present invention encompasses all of the various potential combinations of limitations, recited above and/or elsewhere herein, which relate to the catalyst composition, the catalyst composition precursor, and/or the methods of preparing the catalyst composition, without departing from the intended scope of the present invention.

[0028] The foregoing, as well as other features and advantages of the present invention, will become more apparent from the following description and accompanying drawings.

BRIEF DESCRIPTION OF THE DRAWINGS

[0029] Figure 1 is a photograph of a TEM image of a carbon support with catalyst nanoparticles deposited thereon, in accordance with the present invention.

[0030] Figure 2 is an exploded, schematic structural view showing members of a fuel cell.

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[0031] Figure 3 is cross-sectional view of the assembled fuel cell of Figure 2.

[0032] Figure 4 is a photograph of an electrode array comprising thin film 10 catalyst compositions deposited on individually addressable electrodes, in accordance with the present invention.

[0033] Figure 5 is a X-ray diffraction plot of a supported platinum-copper alloy powder comprising carbon supports with platinum-copper alloy nanoparticles deposited on the carbon supports, such as that illustrated in 15 Figure 1.

[0034] It is to be noted that corresponding reference characters indicate corresponding parts throughout the drawings.

DETAILED DESCRIPTION OF THE INVENTION

- [0035] The present invention is directed to a composition having catalytic activity for use in, for example, oxidation and/or reduction reactions of interest in a polyelectrolyte membrane fuel cell (e.g., an electrocatalyst), the composition comprising, as further detailed herein, platinum and copper.
- [0036] In this regard it is to be noted that, in general, it is desirable, but not essential, to reduce the cost of a catalyst composition to be used in such reactions, particularly when used in a fuel cell. One approach for reducing the cost of the catalyst composition is to decrease the amount of noble metals (such as platinum) used to produce it. Typically, however, as the concentrations of noble metals are decreased, catalyst compositions tend to become more susceptible to corrosion and/or the absolute activity may be diminished. Thus, it is typically desirable to achieve the most activity per weight percent of noble metals (see, e.g., End Current Density /Weight Fraction of Pt, as set forth in Tables A-O, infra). Preferably, this is accomplished without compromising, for example, the life cycle of the fuel cell in which the catalyst composition is placed.
- 35 In addition to, or as an alternative to, reducing cost by limiting the noble metal concentration, a catalyst composition of the present invention may be selected

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because it represents an improvement in corrosion resistance and/or activity compared to platinum (e.g., at least a 3 times increase in electrocatalytic activity compared to platinum).

[0037] The present invention is thus directed to a composition that has catalytic activity in oxidation and/or reduction reactions, and that comprises platinum and copper. Optionally, the catalyst composition of the present invention may be in the form of an alloy of these metals, the composition for example consisting essentially of an alloy containing these metals. Alternatively, the catalyst composition of the present invention may comprise these metals, a portion of which is in the form of an alloy, the composition for example having alloy particles intermixed with oxide particles as a coating, as a pseudo-support, and/or a simple mixture.

[0038] The catalyst composition of the present invention comprises amounts of platinum and copper which are sufficient for these metals to play a role in the catalytic activity and/or crystallographic structure of the catalyst composition. Stated another way, the concentrations of platinum and copper in the present catalyst composition are such that the presence of the metals would not be considered an impurity. For example, the concentrations of each of platinum and copper are at least about 0.1, 0.5, 1, or even 2 atomic percent, wherein the sum of the concentrations of platinum and copper may be, for example, greater than about 95 atomic percent, about 96 atomic percent, about 97 atomic percent, about 98 atomic percent, or even about 99 atomic percent. Advantageously and surprisingly, it has been discovered that catalyst compositions comprising platinum and copper (e.g., alloys) may exhibit favorable electrocatalytic activity while having reduced amounts of platinum, as compared to, for example, a platinum standard.

[0039] In this regard it is to be noted that the catalyst compositions of the present invention may optionally consist essentially of the platinum and copper (e.g., impurities that play little, if any, role in the catalytic activity and/or crystallographic structure of the catalyst may be present to some degree), the concentrations of the metals being within any one or more of the ranges set forth herein for an individual metal, or for the combination of metals. Stated another way, the concentration of a metallic or non-metallic element other than platinum and copper may optionally not exceed what would be considered an impurity (e.g., less than 1, 0.5, 0.1, or 0.01 atomic percent). However, it is possible that the catalyst of the present invention may alternatively comprise platinum and copper, as well as other constituents, including for example platinum and/or copper oxides and/or carbides. It is therefore to be noted that in some

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embodiments the total concentration of platinum and copper may be less than about 100 percent of the metal atoms present therein.

[0040] It is to be further noted that in one or more embodiments of the present invention, platinum and/or copper are substantially in their metallic oxidation states. Stated another way, the average oxidation state of platinum and/or copper are at or near zero. Although in such embodiments there may be portions of the catalyst composition wherein the oxidation states of one or both of platinum and/or copper are greater than zero, the average oxidation states of these elements throughout the entire composition is less than the lowest commonly occurring oxidation state for that particular element (e.g., the lowest commonly occurring oxidation states for platinum and copper are 2 and 1, respectively). Therefore, the average oxidation states of platinum may be, in order of increasing preference, less than 2, 1.5, 1, 0.5, 0.1, or 0.01, or even zero, while the average oxidation state of copper may be, in order of increasing preference, less than 1, 0.5, 0.1, or 0.01, or even zero.

[0041] It is to be still further noted, however, that in an alternative embodiment of the present invention, the platinum and/or copper may not be substantially present in their metallic oxidation states. Stated another way, in one or more embodiments of the present invention, the platinum and/or copper present in the catalyst composition may have an average oxidation state that is greater than zero (the platinum and/or copper being present in the catalyst, for example, as an oxide or as a carbide).

1. Catalyst Compositions

A. Constituent Concentrations

[0042] The concentration of platinum in the catalyst composition of the present invention is greater than about 50 atomic percent, and typically is less than about 80 atomic percent (e.g., greater than about 55, about 60 or even about 65 atomic percent, and less than about 80, about 75, or even about 70 atomic percent). Accordingly, the platinum concentration may, for example, be in the range of from about 60 atomic percent to about 80 atomic percent, or preferably in the range of from about 65 to about 75 atomic percent.

[0043] In this regard it is to be noted, however, that the scope of the present invention is intended to encompass all of the various platinum concentration range permutations possible herein, in view of the above-noted maxima and minima.

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[0044] The concentration of copper in the catalyst composition of the present invention is less than about 50 atomic percent, and typically is greater than about 20 atomic percent (e.g., less than about 45, about 40 or even about 35 atomic percent, and greater than about 20, about 25, or even about 30 atomic percent). Accordingly, the copper concentration may, for example, be in the range of from about 20 atomic percent to about 40 atomic percent, or preferably in the range of from about 25 to about 35 atomic percent.

[0045] In this regard it is to be noted, however, that the scope of the present invention is intended to encompass all of the various copper
10 concentration range permutations possible herein, in view of the above-noted maxima and minima.

[0046] It is to be further noted that the catalyst composition of the present invention may encompass any of the various combinations of platinum and copper concentrations and/or ranges of concentrations set forth above
15 without departing from its intended scope. For example, the catalyst composition of the present invention may comprises platinum and copper, wherein: (i) the sum of the concentrations of platinum and copper is greater than about 95 atomic percent, about 96 atomic percent, about 97 atomic percent, about 98 atomic percent, or even about 99 atomic percent; and (ii) the
20 concentration of platinum is greater than 50 atomic percent and less than about 80 atomic percent, or greater than about 60 atomic percent and less than about 80 atomic percent, greater than about 55 atomic percent and less than about 75 atomic percent.

B. Particle Size

[0047] It is to be noted that, as additionally detailed elsewhere herein, one or more of the methods (e.g., freeze-drying, alloying, washing) and/or conditions thereof (e.g., alloying temperature and/or duration, pH of the acidic solution and/or the atmosphere employed when dissolving, for example, copper from the catalyst composition) employed to prepare the catalyst compositions of the present invention may be controlled in order to control or limit the particle size of the resulting catalyst composition. Preferably, one or more of these methods and/or method conditions are controlled such that the catalyst composition has an average particle size, on for example the electrically conductive support, which is no greater than about 5 nm (50 Å), more preferably no greater than about 3 nm (30 Å), still more

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preferably no greater than about 2.5 nm (25 Å), still more preferably no greater than about 2 nm (20 Å), still more preferably no greater than about 1.5 nm (15 Å), and still more preferably no greater than about 1 nm (10 Å); the average size of the catalyst composition may therefore be in the range of, for example, greater than about 10 Å to less than 50 Å, greater than about 15 Å to less than 40 Å, greater than about 20 Å to less than 35 Å, greater than about 20 Å to less than 30 Å, or greater than about 25 Å to less than 30 Å.

[0048] It is to be noted that, optionally, the size distribution of the catalyst composition particles is such that at least about 75 percent, preferably 80 percent, more preferably 85 percent, and still more preferably 90 percent or more of the particles are within about 75 to about 125 percent, and preferably within about 90 to about 110 percent of the average particle size. Additionally, or alternatively, it is to be further noted that the catalyst composition may have a lattice parameter of less than 3.729 Å (e.g., less than 3.725, 3.720, 3.715, 3.710, 3.705, 3.700, 3.695, 3.690, 3.685, etc.), ranging form example from 3.725 to about 3.685, or from about 3.720 to about 3.690, or from about 3.715 to about 3.695.

C. Compositional Drift

[0049] As has been reported elsewhere, subjecting a catalyst 20 composition to an electrocatalytic reaction (e.g., the operation of a fuel cell) may change the composition by leaching one or more constituents (e.g., copper) from the catalyst (see, e.g., Catalysis for Low Temperature Fuel Cells Part 1: The Cathode Challenges, T.R. Ralph and M.P. Hogarth, Platinum Metals Rev., 2002, 46, (1), p. 3-14). Without being held to any particular theory, it is believed 25 that this leaching effect may potentially act to increase the activity of the catalyst by increasing the surface area and/or by changing the surface composition of the catalyst. In fact, the purposeful leaching of catalyst compositions after synthesis to increase the surface area has been disclosed by Itoh et al. (see, e.g., U.S. Pat. No. 5,876,867). Accordingly, it is to be noted that the 30 concentrations, concentration ranges, and atomic ratios detailed herein for the catalyst compositions of the present invention are intended to include the bulk stoichiometries, any surface stoichiometries resulting therefrom, and modifications of the bulk and/or surface stoichiometries that result by subjecting the catalyst compositions of the present invention to a reaction (e.g., an 35 electrocatalytic reaction) of interest.

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2. Catalyst Composition Precursors

A. Washing/Leaching

[0050] With respect to the above-noted compositional drift that has been observed in use, it is to be further noted that, as illustrated by the results 5 presented in, for example, Tables R1 and R2 herein (see Example 5), it has further been observed that the performance (e.g., activity) of a catalyst composition of the present invention, having a platinum concentration which is greater than 50 atomic percent in use (i.e., after drift has occurred), is improved as compared to a composition that has been prepared to have a concentration 10 of 50 atomic percent platinum or greater prior to use. Stated another way, it has been observed that a catalyst composition comprising platinum and copper as detailed herein which, after the loss of for example copper therefrom, has a platinum concentration that is greater than 50 atomic percent performs better than a catalyst composition that has been prepared to initially have the same, or 15 similar, composition (compare, for example, the relative activities reported for: (i) samples HFC 655, having an initial target composition of $Pt_{25}Cu_{75}$ and a final composition of Pt₅₂Cu₄₈ v. HFC 657, having a comparable composition of Pt₅₀Cu₅₀).

[0051] Accordingly, the present invention is further directed to a 20 precursor to the catalyst compositions of the present invention, the precursor comprising platinum and copper, wherein the concentration of platinum therein is less than 50 atomic percent, and preferably is about 45 atomic percent, more preferably about 40 atomic percent, still more preferably about 35 atomic percent, still more preferably about 30 atomic percent, still more preferably 25 about 25 atomic percent, and still more preferably about 20 atomic percent (preferably ranging, for example, from greater than about 20 to about 40 atomic percent, or more preferably from about 25 to about 35 atomic percent). Additionally, the sum of platinum and copper in the catalyst composition precursor may optionally be at least about 95 atomic percent, preferably about 30 96 atomic percent, more preferably about 97 atomic percent, still more preferably about 98 atomic percent, and still more preferably about 99 atomic percent or more. The concentration of copper in the precursor may therefore be greater than 50 atomic percent (e.g., about 55 atomic percent, 60 atomic percent, 65 atomic percent, 70 atomic percent, 75 atomic percent, or 80 atomic 35 percent), the concentration ranging, for example, from about 60 to about 80 atomic percent, or from about 65 to about 75 atomic percent.

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[0052] The present invention is therefore additionally directed to a method for the preparation of a catalyst composition as set forth herein from a catalyst precursor composition, said precursor composition comprising platinum and copper as set forth herein above (e.g., the sum of the concentrations of 5 platinum and copper therein being, for example, greater than about 95 atomic percent, and the concentration of platinum therein being less than 50, 45, 40, etc. atomic percent). Generally speaking, the method comprises subjecting said precursor composition to conditions sufficient to remove a portion of the copper present therein (such that a catalyst composition, as set forth elsewhere herein 10 is obtained, the catalyst composition comprising, for example, platinum and copper wherein the sum of the concentrations thereof is greater than about 95 atomic percent and the concentration of platinum therein is greater than 50, 55, 60, etc. atomic percent). Optionally, the method, and/or method conditions, are selected in order to obtain a catalyst composition having a particle size that is 15 less than 35 Å (e.g., greater than 20 Å to less than 35 Å, or greater than about 25 Å to less than 30 Å).

[0053] In one preferred embodiment of the above-noted method, the catalyst precursor composition is contacted with an acidic solution to wash or remove a portion of the copper present therein out of the precursor. For example, a given weight of the catalyst precursor composition is contacted with a quantity of a perchloric acid (HClO₄) solution (e.g., 1 M, having a pH of about 0), heated (e.g., about 90 to about 95°C) for a period of time (e.g., about 60 minutes), filtered, and then repeatedly washed with water. The resulting filtrate typically has a pale blue color, indicating the presence of copper ions. The precursor composition is preferably washed a second time, the solid cake isolated from the first filtration step being collected and then subjected to substantially the same sequence of steps as previously performed, the cake being agitated sufficiently to break it apart prior to and/or during the time spent heating the cake/acid solution mixture back up to the desired temperature.

30 After the final filtration has been performed, the isolated cake is dried (e.g., heated at about 90°C for about 48 hours).

[0054] It is to be noted that, in one approach to the above-noted method, the acidic solution may have a pH which is greater than 0 and less than 7, and preferably has a pH which is greater than about 0.25 and less than about 5, still more preferably has a pH which is greater than about 0.5 and less than about 3, and still more preferably has a pH which is greater than about 0.75 and less than about 1.5. Additionally and/or alternatively, the above-noted method is

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carried out in the presence of in air, or alternatively in an atmosphere having an oxygen concentration which is greater than in air.

[0055] It is to be further noted, however, that in an alternative embodiment the catalyst precursor composition may be exposed to conditions 5 common within a fuel cell (e.g., immersion in an electrochemical cell containing an aqueous 0.5 M H₂SO₄ electrolyte solution maintained at room temperature, such as described in Example 4, herein below), in order to leach copper from the precursor. Alternatively, the precursor may be directly subjected to an electrochemical reaction wherein, for example, a hydrogen-containing fuel and 10 oxygen are converted to reaction products and electricity in a fuel cell comprising an anode, a cathode, a proton exchange membrane therebetween, the catalyst precursor composition, and an electrically conductive external circuit connecting the anode and cathode. By contacting the hydrogen-containing fuel or the oxygen and the catalyst precursor composition, the hydrogen-containing 15 fuel is oxidized and/or the oxygen is catalytically reduced. As part of this reaction, copper is thus dissolved in situ from the catalyst precursor composition. After this reaction has been allowed to continue for a length of time sufficient to obtain a substantially stable composition (i.e., a composition wherein the concentration of platinum and/or copper remain substantially 20 constant), the composition may be removed from the cell and used as a catalyst composition in an future fuel cell reaction of interest.

[0056] It is to be still further noted that the method of removing a portion of, for example, the copper from the catalyst composition precursor may be other than herein described without departing from the scope of the present invention. For example, alternative solutions may be used (e.g., HCF₃SO₃H, NAFION™, HNO₃, HCI, H₂SO₄, CH₃CO₂H), and/or alternative concentrations (e.g., about 0.05 M, 0.1 M, 0.5 M, 1 M, 2 M, 3 M, 4 M, 5 M, etc.), and/or alternative temperatures (e.g., about 25°C, 35°C, 45°C, 55°C, 65°C, 75°C, 85°C, etc.), and/or alternative washing times or durations (e.g., about 5 minutes, 10 minutes, 20 minutes, 30 minutes, 40 minutes, 50 minutes, 60 minutes or more), and/or alternative numbers of washing cycles (e.g., 1, 2, 3, 4, 5 or more), and/or alternative washing techniques (e.g., centrifugation, sonication, soaking, electrochemical techniques, or a combination thereof), and/or alternative washing atmospheres (e.g., ambient, oxygen-enriched, argon), as well as various combinations thereof (selected using means common in the art).

[0057] It is to be still further noted that the compositions of the precursors recited above, and/or elsewhere herein, refer to the overall stoichiometries, or bulk stoichiometries, of a prepared precursor composition,

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before being subjected to washing or in situ leaching conditions of some kind (e.g., subjected to use conditions in an electrocatalytic cell). Accordingly, a reported precursor composition (e.g., a precursor composition comprising or consisting essentially of an alloy of the recited metals) is an average 5 stoichiometry over the entire volume of the prepared precursor composition, and therefore, localized stoichiometric variations may exist. For example, the volume of a particle precursor composition comprising the surface and the first few atomic layers inward therefrom may differ from the bulk stoichiometry. Likewise, within the bulk of the particle there may be stoichiometric variations. 10 The surface stoichiometry corresponding to a particular bulk stoichiometry is highly dependant upon the method and conditions under which the precursor composition is prepared. As such, precursor compositions having the same bulk stoichiometry may have significantly different surface stoichiometries. Without being bound to a particular theory, it is believed the differing surface 15 stoichiometries are due at least in part to differences in the atomic arrangements, chemical phases and homogeneity of the compositions.

B. Precursor Lattice Parameters

•:

[0058] The above-noted catalyst composition precursor may also be characterized by its lattice parameter. Specifically, a change in a lattice 20 parameter may be indicative of a resulting change in the size of the respective metal constituents. For example, the 12-coordinate metallic radii of platinum and copper are 1.387 Å and 1.278 Å, respectively. As one metal is substituted for another, the average metal radius and, consequently, the observed lattice parameter may be expected to shrink or expand accordingly. Thus, the average 25 radius may be used as an indicator of lattice changes as a function of stoichiometry, or alternatively, as an indicator of stoichiometry based on observed lattice parameters. It should be noted, however, that while average radii may be useful as a general rule, actual measurements should be expected to conform only in a general manner because local ordering, significant size 30 disparity between atoms, significant changes in symmetry, and/or other factors may produce values that are inconsistent with expectations. Occasionally, the use of alternative metallic radii may be useful. One such alternative radius concept approximates metal radii using known crystallographically ordered Pt-based alloys such as PtCu (cubic symmetry is maintained) instead of pure 35 metals. In this case, the same close-packed geometric arguments are relevant with the exception that the lattice parameter of the ordered metal alloy is used in

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conjunction with the accepted 12-coordinate metallic radius of platinum. According to the alternative radius concept, it is believed that the effective radius of copper is about 1.284 Å.

[0059] In one embodiment of the present invention, the catalyst 5 composition precursor comprises, or consists essentially of, an platinum-copper alloy having a lattice parameter of no more than 3.777 Å, which is believed to generally correspond to an alloy comprising at least 50 atomic percent copper. In another embodiment, the catalyst composition precursor alloy has a lattice parameter of between about 3.674 and about 3.765 Å, which is believed to 10 generally correspond to an alloy comprising between about 15 and about 45 atomic percent platinum and between about 55 and about 85 atomic percent copper. In yet another embodiment, the catalyst composition precursor alloy has a lattice parameter of about 3.689 and about 3.750 Å, which is believed to generally correspond to an alloy comprising between about 20 and about 40 15 atomic percent platinum and between about 60 and about 80 atomic percent copper. In still another embodiment, the catalyst composition precursor alloy has a lattice parameter of between about 3.704 and about 3.745 Å, which is believed to generally correspond to an alloy comprising between about 25 and about 35 atomic percent platinum and between about 65 and about 75 atomic 20 percent copper.

[0060] In this regard it is to be noted that the lattice parameters recited above are for the precursor catalyst compositions (i.e., compositions prior to washing or leaching to remove a portion of, for example, copper therein). It is to be further noted that after washing or leaching, some type of skeleton structure or formation may result in lattice parameters that deviate from the above-described ranges versus compositions.

3. Formation of Catalyst Composition Precursors Comprising/Consisting Essentially of an Alloy

[0061] The catalyst composition, and/or the catalyst composition precursor, of the present invention may consist essentially of an alloy of platinum and copper. Alternatively, the catalyst composition, and/or the catalyst composition precursor, of the present invention may comprise an alloy of platinum and copper; that is, one or both of these may alternatively comprise an alloy of these metals, and optionally one or more of these metals in a non-alloy form (e.g., a platinum and/or copper salt and/or oxide and/or carbide).

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[0062] Such alloys may be formed by a variety of methods. For example, the appropriate amounts of the constituents (e.g., metals) may be mixed together and heated to a temperature above the respective melting points to form a molten solution of the metals that is cooled and allowed to solidify.

[0063] Typically, the catalyst compositions of the present invention, and/or the precursors thereto, are used in a powder form to increase the surface area, which in turn increases the number of reactive sites, and thus leads to improved efficiency of the cell in which the catalyst compositions are being used. Thus, a formed catalyst composition alloy, and/or the precursor thereto, may be transformed into a powder after being solidified (e.g., by grinding), or during solidification (e.g., spraying molten alloy and allowing the droplets to solidify). In this regard it is to be noted, however, that in some instances it may be advantageous to evaluate alloys for electrocatalytic activity in a non-powder form, as further described and illustrated elsewhere herein (see, e.g., Examples 1 and 2, infra).

[0064] To further increase surface area and efficiency, a catalyst composition alloy (i.e., a catalyst composition comprising or consisting essentially of an alloy), and/or the precursor thereto, may be deposited over the surface of electrically conductive supports (e.g., carbon black) for use in a fuel 20 cell. One method for loading a catalyst composition or precursor alloy onto supports typically comprises depositing metal-containing (e.g., platinum and/or copper) compounds onto the supports, converting these compounds to metallic form, and then alloying the metals using a heat-treatment in a reducing atmosphere (e.g., an atmosphere comprising an inert gas such as argon and/or 25 a reducing gas such as hydrogen). One method for depositing these compounds involves the chemical precipitation thereof onto the supports. The chemical precipitation method is typically accomplished by mixing supports and sources of the metal compounds (e.g., an aqueous solution comprising one or more inorganic metal salts) at a concentration sufficient to obtain the desired 30 loading of the catalyst composition, or precursor thereto, on the supports, after which precipitation of the compounds is initiated (e.g., by adding an ammonium hydroxide solution). The slurry is then typically filtered from the liquid under vacuum, washed with deionized water, and dried to yield a powder that comprises the metal compounds on the supports.

[0065] Another method for depositing the metal compounds comprises forming a suspension comprising a solution and supports suspended therein, wherein the solution comprises a solvent portion and a solute portion that comprises the metal compound(s) being deposited. The suspension is frozen to

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deposit (e.g., precipitate) the compound(s) on the support particles. The frozen suspension is then freeze-dried to remove the solvent portion, leaving a freeze-dried powder comprising the supports and the deposits of the metal compound(s) on the supports.

[0066] Since the method may involve sublimation of the solvent portion from the frozen suspension, the solvent portion of the solution in which the supports are suspended preferably has an appreciable vapor pressure below its freezing point. Examples of such sublimable solvents that also dissolve many metal-containing compounds and metals include water, alcohols (e.g., methanol, ethanol, etc.), acetic acid, carbon tetrachloride, ammonia, 1,2-dichloroethane, N,N-dimethylformamide, formamide, etc.

[0067] The solution in which the supports are dispersed/suspended provides the means for delivering the metal species which is to be deposited onto the surfaces of the supports. The metal species may be the final desired form, but in many instances it is not. If the metal species is not a final desired form, the deposited metal species may be subsequently converted to the final desired form. Examples of such metal species that may be subsequently converted include inorganic and organic metal compounds such as metal halides, sulfates, carbonates, nitrates, nitrites, oxalates, acetates, formates, etc.

20 Conversion to the final desired form may be made by thermal decomposition, chemical reduction, or other reaction. Thermal decomposition, for example, is brought about by heating the deposited metal species to obtain a different solid material and a gaseous material. In general, as is known, thermal decomposition of halides, sulfates, carbonates, nitrates, nitrites, oxalates, acetates, and formates may be carried out at temperatures between about 200 and about 1,200°C.

[0068] If conversion of the deposited metal species to the final desired form is to occur, the deposited metal species is usually selected such that any unwanted by-products from the conversion can be removed from the final product. For example, during thermal decomposition the unwanted decomposition products are typically volatilized. To yield a final product that is a metal alloy, the deposited metal species are typically selected so that the powder comprising the deposited metal species may be reduced without significantly altering the uniformity of the metal deposits on the surface of the supports and/or without significantly altering the particle size of the final powder (e.g., through agglomeration).

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[0069] Nearly any metal may be deposited onto supports by one or more of the methods noted herein, provided that the metal or compound containing the metal is capable of being dissolved in a suitable medium (i.e., a solvent). Likewise, nearly any metal may be combined with, or alloyed with, any other metal provided the metals or metal-containing compounds are soluble in a suitable medium.

[0070] The solute portion may comprise an organometallic compound and/or an inorganic metal-containing compound as a source of the metal species being deposited. In general, organometallic compounds are more costly, may contain more impurities than inorganic metal-containing compounds, and may require organic solvents. Organic solvents are more costly than water and typically require procedures and/or treatments to control purity or negate toxicity. As such, organometallic compounds and organic solvents are generally not preferred. An example of an appropriate inorganic salt is Cu(NO₃)₂•2H₂O, which is highly soluble in water. As a result, water is often considered to be a preferred solvent. In some instances, it is desirable for an inorganic metal-containing compound to be dissolved in an acidic solution prior to being mixed with other inorganic metal-containing compounds.

[0071] To form a catalyst alloy, or catalyst precursor alloy, having a 20 particular composition or stoichiometry, the amounts of the various metalcontaining source compounds necessary to achieve that composition are determined in view thereof. If the supports have a pre-deposited metal, the loading of the pre-deposited metal on the supports is typically taken into account when calculating the necessary amounts of metal-containing source 25 compounds. After the appropriate amounts of the metal-containing compounds are determined, the solution may be prepared by any appropriate method. For example, if all the selected metal-containing source compounds are soluble at the desired concentration in the same solvent at room temperature, they may merely be mixed with the solvent. Alternatively, the suspending solution may be 30 formed by mixing source solutions, wherein a source solution comprises a particular metal-containing source compound at a particular concentration. If, however, all of the selected compounds are not soluble at the same temperature when mixed together (either as powders in a solvent or as source solutions), the temperature of the mixture may be increased to increase the solubility limit of 35 one or more of the source compounds so that the suspending solution may be formed. In addition to adjusting solubility with temperature, the stability of the suspending solution may be adjusted, for example, by the addition of a buffer, by the addition of a complexing agent, and/or by adjusting the pH.

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[0072] In addition to varying the amounts of the various metals to form alloys having different compositions, this method allows for a wide variation in the loading of the metal onto the supports. This is beneficial because it allows for the activity of a supported catalyst composition (e.g., an electrocatalyst 5 powder) to be maximized. The loading may be controlled in part by adjusting the total concentration of the various metals in the solution while maintaining the relative amounts of the various metals. In fact, the concentrations of the inorganic metal-containing compounds may approach the solubility limit for the solution. Typically, however, the total concentration of inorganic metal-10 containing compounds in the solution is between about 0.01 M and about 5 M, which is well below the solubility limit. In one embodiment, the total concentration of inorganic metal-containing compounds in the solution is between about 0.1 M and about 1 M. Concentrations below the solubility limit are used because it is desirable to maximize the loading of the supported 15 catalysts without decreasing the surface area of the metal deposits. Depending, for example, on the particular composition, the size of the deposits, and the uniformity of the distribution of deposits on the supports, the loading may typically be between about 5 and about 60 weight percent. In one embodiment, the loading is between about 15 and about 45 or about 55 weight percent, or 20 between about 20 and about 40 or about 50 weight percent. In another embodiment, the loading is about 20 weight percent, about 40 weight percent, or about 50 weight percent.

[0073] The supports upon which the metal species (e.g., metalcontaining compound) is to be deposited may be of any size and composition 25 that is capable of being dispersed/suspended in the solution during the removal of heat to precipitate the metal species thereon. The maximum size depends on several parameters including agitation of the suspension, density of the supports, specific gravity of the solution, and the rate at which heat is removed from the system. In general, the supports are electrically conductive and are 30 useful for supporting catalytic compounds in fuel cells. Such electrically conductive supports are typically inorganic, for example, carbon supports. However, the electrically conductive supports may comprise an organic material such as an electrically conductive polymer (see, e.g., in U.S. Pat. No. 6,730,350). Carbon supports may be predominantly amorphous or graphitic and 35 they may be prepared commercially, or specifically treated to increase their graphitic nature (e.g., heat treated at a high temperature in vacuum or in an inert gas atmosphere) thereby increasing corrosion resistance. Carbon black support particles may have a Brunauer, Emmett and Teller (BET) surface area up to

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about 2000 m²/g. It has been reported that satisfactory results are achieved using carbon black support particles having a high mesoporous area, e.g., greater than about 75 m²/g (see, e.g., Catalysis for Low Temperature Fuel Cells Part 1: The Cathode Challenges, T.R. Ralph and M.P. Hogarth, Platinum Metals Rev., 2002, 46, (1), p. 3-14). Experimental results to-date indicate that a surface area of about 500 m²/g is preferred.

[0074] In another embodiment, the supports may have a pre-deposited material thereon. For example, when the final composition of the deposits on the carbon supports is a platinum alloy, it may be advantageous to use a carbon supported platinum powder. Such powders are commercially available from companies such as Johnson Matthey, Inc., of New Jersey and E-Tek Div. of De-Nora, N.A., Inc., of Somerset, New Jersey and may be selected to have a particular loading of platinum. The amount of platinum loading is selected in order to achieve the desired stoichiometry of the supported metal alloy.
15 Typically, the loading of platinum is between about 5 and about 60 weight percent. Preferably, the loading of platinum is between about 15 and 45 weight percent. The size (i.e., the maximum cross-sectional length) of the platinum deposits is typically less than about 20 nm. For example, the size of the platinum deposits may be less than about 10 nm, 5 nm, 2 nm, or smaller;
20 alternatively, the size of the platinum deposits may be between about 2 and about 3 nm. Experimental results to-date indicate that a desirable supported platinum powder may be further characterized by having a platinum surface area

about 3 nm. Experimental results to-date indicate that a desirable supported platinum powder may be further characterized by having a platinum surface area of between about 150 and about 170 m²/g (determined by CO adsorption), a combined carbon and platinum surface area of between about 350 and about 400 m²/g (determined by N₂ adsorption), and an average support size that is between about 100 and about 300 nm.

[0075] The solution and supports are mixed according to any appropriate method to form the dispersion/suspension, using means known in the art. Exemplary methods of mixing include magnetic stirring, insertion of a stirring
30 structure or apparatus (e.g., a rotor), shaking, sonication, or a combination of the foregoing methods. Provided that the supports can be adequately mixed with the solution, the relative amounts of supports and solution may vary over a wide range. For example, when preparing carbon supported catalysts using an aqueous suspension comprising dissolved inorganic metal-containing
35 compounds, the carbon supports typically comprise between about 1 and about 30 weight percent of the suspension. Preferably, however, the carbon supports comprise between about 1 and about 15 weight percent of the suspension, between about 1 and about 10 weight percent of the suspension, between about

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3 and about 8 weight percent of the suspension, between about 5 and about 7 weight percent of the suspension, or about 6 weight percent of the suspension.

[0076] In this regard it is to be noted that the above-referenced amounts of carbon supports in suspension may apply equally to other, non-carbon supports noted herein, or which are known in the art.

[0077] The relative amounts of supports and solution may also be described in terms of volumetric ratios. For example, the dispersion/suspension may have a volumetric ratio of support particles to solution or solvent that is at least about 1:10. Specifying a minimum volumetric ratio indicates that the volume of support particles may be increased relative to the volume of solution or solvent. As such, the volume ratio of support particles to solution or solvent may more preferably be at least about 1:8, about 1:5, or even about 1:2.

[0078] In one method of preparation, the solution and supports described or illustrated herein are mixed using sonication at a power and for a duration sufficient to form a dispersion/suspension in which the pores of the supports are impregnated with the solution and/or the supports are uniformly distributed throughout the solution. If the dispersion/suspension is not uniformly mixed (i.e., the supports are not uniformly impregnated with the solution and/or the supports are not uniformly distributed throughout the solution), the deposits formed on the supports will typically be non-uniform (e.g., the loading of the metal species may vary among the supports, the size of the deposits may vary significantly on a support and/or among the supports, and/or the composition of the deposits may vary among the supports). Although a uniform mixture, or distribution of supports in the solution, is generally preferred, there may be circumstances in which a non-uniform mixture, or distribution of supports in the solution, is desirable.

[0079] When a freeze-drying method of preparation is employed, typically the uniformity of the distribution of particles in the dispersion/suspension is maintained throughout the removal of heat therefrom.
30 This uniformity may be maintained by continuing the mixing of the dispersion/suspension as it is being cooled. The uniformity may, however, be maintained without mixing by the viscosity of the dispersion/suspension. The actual viscosity needed to uniformly suspend the support particles depends in large part on the amount of support particles in the dispersion/suspension and 35 the size of the support particles. To a lesser degree, the necessary viscosity depends on the density of the support particles and the specific gravity of the solution. In general, the viscosity is typically sufficient to prevent substantial settling of the support particles as the heat is being removed from the

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suspension to precipitate the deposits, and/or, if desired, until the dispersion/suspension is solidified by the freezing of the solution or solvent. The degree of settling, if any, may be determined, for example, by examining portions of the solidified or frozen suspension. Typically, substantial settling would be considered to have occurred if the concentration of supports in any two portions varies by more than about ±10%. When preparing a carbon supported catalyst powder, or precursors thereto, in accordance with the freeze-drying method, the viscosity of the suspension/dispersion is typically sufficient to prevent substantial settling for at least about 4 minutes. In fact, the viscosity of the suspension/dispersion may be sufficient to prevent substantial settling for at least about 10 minutes, at least about 30 minutes, at least about 1 hour, at least about 6 hours, at least about 12 hours, at least about 18 hours, or even up to about 2 days. Typically, the viscosity of the dispersion/suspension is at least about 5,000 mPa*s.

[0080] Heat is removed from the dispersion/suspension so that at least a 15 part of the solute portion separates from the solvent portion and deposits (e.g., precipitates) a metal species/precipitated metal onto the supports and/or onto any pre-existing deposits (e.g., a pre-deposited metal and/or pre-deposited metal species formed, for example, by precipitation of incompatible solutes). If 20 the concentration of supports in the suspension is sufficient (e.g., within the ranges set forth above) and enough heat is removed, nearly all of the metal species to be deposited is separated from the solvent portion to form deposits (e.g., precipitates) comprising the metal species on the supports. In one embodiment, the heat is removed to solidify or freeze the dispersion/suspension 25 and form a composite comprising the supports/particulate support with deposits comprising the metal species or a precipitated metal on the supports/particulate support, within a matrix of the solvent portion in a solid state. If the concentration of the solute portion in the solution exceeds the ability of the supports to accommodate deposits of the metal species, some of the solute 30 portion may crystallize within the matrix. If this occurs, such crystals are not considered to be a supported powder.

[0081] In one embodiment of the present invention, the size of the deposits of the metal species is controlled such that the eventually formed deposits of the catalyst composition alloy, or precursor thereto, are as previously noted; that is, the particle size is preferably no greater than about 5 nm (50 Å), more preferably no greater than about 4 nm (40 Å), still more preferably no greater than about 3 nm (30 Å), still more preferably no greater than about 3 nm (30 Å), still more preferably no greater than about 2.5 nm (25 Å), still more

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preferably no greater than about 2 nm (20 Å), still more preferably no greater than about 1.5 nm (15 Å), and still more preferably no greater than about 1 nm (10 Å); the average size of the catalyst composition may therefore be in the range of, for example, greater than about 10 Å to less than 50 Å, greater than about 15 Å to less than 40 Å, greater than about 20 Å to less than 35 Å, or greater than about 25 Å to less than 30 Å.

[0082] As previously noted, control of the deposit size, or more generally the size of the catalyst composition alloy, or precursor thereto, may be accomplished, at least in part, by maintaining a well-impregnated and uniformly distributed suspension throughout the removal of heat from the system. Additionally, the control of the deposit size may be accomplished by rapidly removing heat from the dispersion/suspension as the compound or compounds are depositing on supports.

[0083] The rapid heat removal may be accomplished by cooling the
15 dispersion/suspension from a temperature of at least about 20°C to a
temperature below the freezing point of the solvent at a rate of, for example, at
least about 20°C/minute. In order of increasing preference, heat removal may
comprise cooling the dispersion/suspension at a rate of at least about 50, 60,
70, 80, 90, or 100°C/minute. As such, the dispersion/suspension may be cooled
20 at a rate that is between about 50 and about 100°C/minute, or at a rate that is
between about 60 and about 80°C/minute. Typically, removal of heat is at a rate
that allows for the temperature of the suspension to be reduced from a
temperature such as room temperature (about 20°C) or higher (e.g., about
100°C) to the freezing point of the solution or solvent within a relatively short
25 period of time (e.g., not more than about 10, 5, or 3 minutes).

[0084] The heat may be removed from the dispersion/suspension by any appropriate method. For example, a container containing a volume of the dispersion/suspension may be placed within a refrigeration unit such as freeze-dryer, a volume of dispersion/suspension may be contacted with a cooled surface (e.g., a plate or container), a volume of dispersion/suspension in a container may be immersed in, or otherwise contacted with, a cryogenic liquid. Advantageously, the same container may also be used during the formation of the dispersion and/or during the separation of solvent from deposited supports. In one embodiment a cover is placed over an opening of the container.
35. Although the cover may completely prevent the escape of any solid matter from

35 Although the cover may completely prevent the escape of any solid matter from the container, the cover preferably allows for a gas to exit the container while substantially preventing the supports from exiting the container. An example of such a cover includes a stretchable film (e.g., PARAFILM) having holes that are,

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for example, less than about 500 , 400, or 300 μm in size (maximum length across the hole).

[0085] In one embodiment the dispersion/suspension is cooled at a rate of at least about 20 °C/minute by immersing or contacting a container containing 5 the dispersion/suspension in or with a volume of cryogenic liquid within a cryogenic container sized and shaped so that at least a substantial portion of its surface is contacted with the cryogenic liquid (e.g., at least about 50, 60, 70, 80, or 90 percent of the surface of the dispersion/suspension container). The cryogenic liquid is typically at a temperature that is at least about 20 °C below 10 the freezing point of the solvent. Examples of suitable cryogenic liquids typically include liquid nitrogen, liquid helium, liquid argon, but even less costly media may be utilized (for example, an ice water/hydrous calcium chloride mixture can reach temperatures down to about -55 °C, an acetone/dry ice mixture can reach temperatures down to about -78 °C, and a diethyl ether/dry ice mixture can reach temperatures down to about -100 °C).

[0086] The container may be made of nearly any type of material.

Generally, the selected material does not require special handling procedures, can withstand repeated uses without structural failure (e.g., resistant to thermal shock), does not contribute impurities to the suspension (e.g., resistant to chemical attack), and is thermally conductive. For example, plastic vials made from high density polyethylene may be used.

[0087] The supports having the deposits thereon may be separated from the solvent portion by any appropriate method such as filtration, evaporation (e.g., by spray-drying), sublimation (e.g., freeze-drying), or a combination
25 thereof. The evaporation or sublimation rate may be enhanced by adding heat (e.g., raising the temperature of the solvent) and/or decreasing the atmospheric pressure to which the solvent is exposed.

[0088] In one embodiment a frozen or solidified suspension is freeze-dried to remove the solvent portion therefrom. The freeze-drying may be carried out in any appropriate apparatus, such as a LABCONCO FREEZE DRY SYSTEM (Model 79480). Intuitively, one of skill in the art would typically maintain the temperature of the frozen suspension below the melting point of the solvent (i.e., the solvent is removed by sublimation), in order to prevent agglomeration of the supports. The freeze-drying method described or illustrated herein may be carried out under such conditions. Surprisingly, however, it is not critical that the solvent portion remain fully frozen. Specifically, it has been discovered that a free-flowing, non-agglomerated powder may be prepared even if the solvent is allowed to melt, provided that the pressure within

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the freeze-dryer is maintained at a level that the evaporation rate of the liquid solvent is faster than the melting rate (e.g., below about 0.2 mbar, 0.000197 atm, or 20 Pa). Thus, there is typically not enough solvent in the liquid state to result in agglomeration of the supports. Advantageously, this can be used to decrease the time needed to remove the solvent portion. Removing the solvent portion results in a free-flowing, non-agglomerated supported powder that comprises the supports/particulate support and deposits comprising one or more metal species or precipitated metals on the supports/particulate support.

[0089] To accomplish the conversion of the deposited compound(s) to the desired form of the metal(s) therein, the support and deposited compound(s) are typically heated in a reducing atmosphere (e.g., an atmosphere containing hydrogen and/or an inert gas such as argon) at a temperature sufficient to decompose the deposited compound(s). The temperature reached during the thermal treatment is typically at least as high as the decomposition temperature(s) for the deposited compound(s) and not so high as to result in degradation of the supports and agglomeration of the supports and/or the deposits. Typically, the temperature is between about 60 °C and about 1100 °C, between about 100 and about 1000 °C, between about 200 and about 800 °C, or between about 400 and about 600 °C. Inorganic metal-containing compounds typically decompose at temperatures between about 600 and 1000 °C.

[0090] The duration of the heat treatment is typically at least sufficient to substantially convert the deposited compounds to the desired state. In general, the temperature and time are inversely related (i.e., conversion is accomplished in a shorter period of time at higher temperatures and vice versa). At the temperatures typical for converting the inorganic metal-containing compounds to an alloy set forth above, the duration of the heat treatment is typically at least about 30 minutes (e.g., about 1, 2, 4, 6, 8, 10, 12 hours, 14 hours or longer). For example, the duration may be between about 1 and about 14 hours, about 2 and about 12 hours, or between about 4 and about 6 hours.

[0091] In this regard it is to be noted, however, that the particle size of the resulting catalyst composition alloy, or precursor thereto, may additionally or alternatively be controlled by control of the temperature at which the deposited metal-containing compounds are heated, and/or the length of time over which the compounds are maintained at that temperature. For example, in order to obtain a catalyst composition, or catalyst composition precursor, having the size as noted elsewhere herein (e.g., greater than about 10 Å to less than 50 Å, greater than about 15 Å to less than 40 Å, greater than about 20 Å to less than



35 Å, or greater than about 25 Å to less than 30 Å), in one embodiment the deposited compound(s) is(are) heated in a reducing atmosphere to a temperature which is greater than about 450°C and less than 800°C, more preferably greater than about 450°C and less than about 750°C, still more 5 preferably greater than about 525°C and less than about 750°C, and still more preferably greater than about 600°C and less than about 700°C, for a duration sufficient to convert said compounds to an alloy of copper and platinum (e.g., preferably for about 2 to about 14 hours, more preferably for about 6 to about 14 hours, still more preferably for about 6.5 to about 13 hours, and still more 10 preferably for about 7 to about 12 hours). In an alternative embodiment, the deposited compound(s) is(are) heated in a reducing atmosphere to a temperature which is greater than about 750°C and less than 950°C, and more preferably greater than about 800°C and less than about 900°C, for a duration of about 1.5 to about 5 hours, more preferably for about 1.75 to about 4.5 hours, 15 and still more preferably for about 2 to about 4 hours).

[0092] Referring now to Figure 1, a carbon supported catalyst alloy powder particle 1 of the present invention, produced in accordance with the freeze-drying method described or illustrated herein, comprises a carbon support 2 and deposits 3 of the catalyst alloy on the support. A particle and a 20 powder comprising said particles may have a loading that is up to about 90 weight percent. However, when a supported catalyst powder is used as a fuel cell catalyst, the loading is typically between about 5 and about 60 weight percent, and is preferably between about 15 and about 45 or about 55 weight percent, or more preferably between about 20 and about 40 or 50 weight 25 percent (e.g., about 20 weight percent, 45 weight percent, or about 50 weight percent). Increasing the loading to greater than about 60 weight percent does not typically result in an increase in the activity. Without being held to a particular theory, it is believed that excess loading covers a portion of the deposited metal and the covered portion cannot catalyze the desired 30 electrochemical reaction. On the other hand, the activity of the supported catalyst typically decreases significantly if the loading is below about 5 weight percent.

[0093] The freeze-dry method may be used to produce supported catalyst alloy powders that are heavily loaded with nanoparticle deposits of a catalyst alloy that comprises one or more non-noble metals, wherein the deposits have a relatively narrow size distribution. For example, in one embodiment the supported non-noble metal-containing catalyst alloy powder may have a metal loading of at least about 20 weight percent of the powder, an

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average deposit size that is no greater than about 10 nm, and a deposit size distribution in which at least about 70 percent of the deposits are within about 50 and 150 percent of the average deposit size. In another embodiment, the metal loading may preferably be between about 20 and about 60 weight percent, and 5 more preferably between about 20 and about 40 weight percent.

[0094] The freeze-dry method of preparing supported catalyst powders allows for improved control of the stoichiometry of the deposits because the suspension is preferably kept within a single container, the solution is not physically separated from the supports (e.g., by filtration), and freezing results in substantially all of the solute precipitating on the supports. Additionally, the deposits tend to be isolated, small, and uniformly dispersed over the surface of the supports, thereby increasing the overall catalytic activity. Still further, because filtering is not necessary, extremely fine particles are not lost and the supported catalyst powders produced by this method tend to have a greater surface area and activity. Also, the act of depositing the metal species on the supports is fast. For example, immersing a container of the dispersion/suspension in a cryogenic liquid may solidify the dispersion/suspension in about three to four minutes.

4. Unsupported Catalyst Compositions in Electrode/Fuel Cell Applications

[0095] It is to be noted that, in another embodiment of the present invention; a catalyst composition (e.g., the catalyst composition comprising or consisting essentially of an alloy of the metal components), and/or the precursor thereto, may be unsupported; that is, a catalyst composition as set forth herein may be employed in the absence of support particles. More specifically, it is to be noted that in another embodiment of the present invention a catalyst composition comprising platinum and copper as defined herein may be directly deposited (e.g., sputtered) onto, for example: (i) a surface of one or both of the electrodes (e.g., the anode, the cathode or both), and/or (ii) one or both surfaces of a polyelectrolyte membrane, and/or (iii) some other surface, such as a backing for the membrane (e.g., carbon paper).

[0096] In this regard it is to be further noted that each constituent (e.g., metal-containing compound) of the composition may be deposited separately, each for example as a separate layer on the surface of the electrode, membrane, etc. Alternatively, two or more constituents may be deposited at the same time. Additionally, when the composition comprises or consists essentially of an alloy of these metals, the alloy may be formed and then deposited, or the

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constituents thereof may be deposited and then the alloy subsequently formed thereon.

[0097] Deposition of the constituent(s) may be achieved using means known in the art, including for example known sputtering techniques (see, e.g., 5 PCT Application No. WO 99/16137, or U.S. Patent No. 6,171,721). Generally speaking, however, in one approach sputter-deposition is achieved by creating, within a vacuum chamber in an inert atmosphere, a voltage differential between a target component material and the surface onto which the target constituent is to be deposited, in order to dislodge particles from the target constituent material 10 which are then attached to the surface of, for example, an electrode or electrolyte membrane, thus forming a coating of the target constituent thereon. In one embodiment, the constituents are deposited on a polymeric electrolyte membrane, including for example (i) a copolymer membrane of tetrafluoroethylene and perfluoropolyether sulfonic acid (such as the membrane 15 material sold under the trademark NAFION™), (ii) a perfluorinated sulfonic acid polymer (such as the membrane material sold under the trademark ACIPLEX), (iii) polyethylene sulfonic acid polymers, (iv) polyketone sulfonic acids, (v) polybenzimidazole doped with phosphoric acid, (vi) sulfonated polyether sulfones, and (vii) other polyhydrocarbon-based sulfonic acid polymers.

[0098] It is to be noted that the specific amount of each metal or constituent of the composition may be controlled independently, in order to tailor the composition to a given application. In some embodiments, however, the amount of each deposited constituent, or alternatively the amount of the deposited catalyst (e.g., catalyst alloy), may be less than about 5 mg/cm² of surface area (e.g., electrode surface area, membrane surface area, etc.), less than about 1 mg/cm², less than about 0.5 mg/cm², less than about 0.1 mg/cm², or even less than about 0.05 mg/cm². In other embodiments, the amount of the deposited constituent, or alternatively the amount of the deposited catalyst (e.g., catalyst alloy), may range from about 0.5 mg/cm² to less than about 5 mg/cm².

[0099] It is to be further noted that the specific amount of each constituent, or the composition, and/or the conditions under which the constituent, or composition, are deposited, may be controlled in order to control the resulting thickness of the constituent, or composition, layer on the surface of the electrode, electrolyte membrane, etc. For example, as determined by means known in the art (e.g., scanning electron microscopy or Rutherford back scattering spectrophotometric method), the deposited layer of the constituent or composition may have a thickness ranging from several angstroms (e.g., about

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2, 4, 6, 8, 10Å or more) to several tens of angstroms (e.g., about 20, 40, 60, 80, 100Å or more), up to several hundred angstroms (e.g., about 200, 300, 400, 500Å or more). Additionally, after all of the constituents have been deposited, and optionally alloyed (or, alternatively, after the composition has been deposited, and optionally alloyed), the layer of the composition of the present invention may have a thickness ranging from several tens of angstroms (e.g., about 20, 40, 60, 80, 100Å or more), up to several hundred angstroms (e.g., about 200, 400, 600, 800, 1000, 1500Å or more). Thus, in different embodiments the thickness may be, for example, between about 10 and about 10 500 angstroms (Å), between about 20 and about 200 angstroms (Å), and between about 40 and about 100 angstroms (Å).

[0100] It is to be still further noted that in embodiments wherein a composition (or the constituents thereof) is deposited as a thin film on the surface of, for example, an electrode or electrolyte membrane, the various
15 concentration of platinum and copper therein may be as previously described herein. Additionally, in other embodiments, the concentration of platinum and/or copper in the composition may be other than as previously described.

5. Incorporation of the Composition in a Fuel Cell

[0101] The compositions of the present invention are particularly suited
20 for use as catalysts in proton exchange membrane fuel cells. As shown in Figures 2 and 3, a fuel cell, generally indicated at 20, comprises a fuel electrode (anode) 22 and an air electrode/oxidizer electrode (cathode) 23. In between the electrodes 22 and 23, a proton exchange membrane 21 serves as an electrolyte and is usually a strongly acidic ion exchange membrane, such as a
25 perfluorosulphonic acid-based membrane. Preferably, the proton exchange membrane 21, the anode 22, and the cathode 23 are integrated into one body to minimize contact resistance between the electrodes and the proton exchange membrane. Current collectors 24 and 25 engage the anode and the cathode, respectively. A fuel chamber 28 and an air chamber 29 contain the respective
30 reactants and are sealed by sealants 26 and 27, respectively.

[0102] In general, electricity is generated by hydrogen-containing fuel combustion (i.e., the hydrogen-containing fuel and oxygen react to form water, carbon dioxide and electricity). This is accomplished in the above-described fuel cell by introducing the hydrogen-containing fuel F into the fuel chamber 28, while oxygen O (preferably air) is introduced into the air chamber 29, whereby an electric current can be immediately transferred between the current collectors 24

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and 25 through an outer circuit (not shown). Ideally, the hydrogen-containing fuel is oxidized at the anode 22 to produce hydrogen ions, electrons, and possibly carbon dioxide gas. The hydrogen ions migrate through the strongly acidic proton exchange membrane 21 and react with oxygen and electrons transferred through the outer circuit to the cathode 23 to form water. If the hydrogen-containing fuel F is methanol, it is preferably introduced as a dilute acidic solution to enhance the chemical reaction, thereby increasing power output (e.g., a 0.5 M methanol/0.5 M sulfuric acid solution).

[0103] To prevent the loss of ionic conduction in the proton exchange 10 membranes, these typically remain hydrated during operation of the fuel cell. As a result, the material of the proton exchange membrane is typically selected to be resistant to dehydration at temperatures up to between about 100 and about 120 °C. Proton exchange membranes usually have reduction and oxidation stability, resistance to acid and hydrolysis, sufficiently low electrical resistivity 15 (e.g., <10 Ω•cm), and low hydrogen or oxygen permeation. Additionally, proton exchange membranes are usually hydrophilic. This ensures proton conduction (by reversed diffusion of water to the anode), and prevents the membrane from drying out thereby reducing the electrical conductivity. For the sake of convenience, the layer thickness of the membranes is typically between 50 and 20 200 µm. In general, the foregoing properties are achieved with materials that have no aliphatic hydrogen-carbon bonds, which, for example, are achieved by replacing hydrogen with fluorine or by the presence of aromatic structures; the proton conduction results from the incorporation of sulfonic acid groups (high acid strength). Suitable proton-conducting membranes also include 25 perfluorinated sulfonated polymers such as NAFION™ and its derivatives produced by E.I. du Pont de Nemours & Co., Wilmington, Delaware. NAFION™ is based on a copolymer made from tetrafluoroethylene and perfluorovinylether, and is provided with sulfonic groups working as ion-exchanging groups. Other suitable proton exchange membranes are produced with monomers such as 30 perfluorinated compounds (e.g., octafluorocyclobutane and perfluorobenzene), or even monomers with C-H bonds that do not form any aliphatic H atoms in a plasma polymer, which could constitute attack sites for oxidative breakdown.

[0104] The electrodes of the present invention comprise the catalyst compositions of the present invention and an electrode substrate upon which the catalyst is deposited. In one embodiment, the composition is directly deposited on the electrode substrate. In another embodiment, the composition is supported on electrically conductive supports and the supported composition is deposited on the electrode substrate. The electrode may also comprise a

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proton conductive material that is in contact with the composition. The proton conductive material may facilitate contact between the electrolyte and the composition, and may thus enhance fuel cell performance. Preferably, the electrode is designed to increase cell efficiency by enhancing contact between the reactant (i.e., fuel or oxygen), the electrolyte and the composition. In particular, porous or gas diffusion electrodes are typically used since they allow the fuel/oxidizer to enter the electrode from the face of the electrode exposed to the reactant gas stream (back face), and the electrolyte to penetrate through the face of the electrode exposed to the electrolyte (front face), and reaction products, particularly water, to diffuse out of the electrode.

[0105] Preferably, the proton exchange membrane, electrodes, and catalyst composition are in contact with each other. This is typically accomplished by depositing the composition either on the electrode, or on the proton exchange membrane, and then placing the electrode and membrane in 15 contact. The composition of this invention can be deposited on either the electrode or the membrane by a variety of methods, including plasma deposition, powder application (the powder may also be in the form of a slurry, a paste, or an ink), chemical plating, and sputtering. Plasma deposition generally entails depositing a thin layer (e.g., between 3 and 50 µm, preferably between 5 20 and 20 µm) of a catalyst composition on the membrane using low-pressure plasma. By way of example, an organic platinum compound such as trimethylcyclopentadienyl-platinum is gaseous between 10⁻⁴ and 10 mbar and can be excited using radio-frequency, microwaves, or an electron cyclotron resonance transmitter to deposit platinum on the membrane. According to 25 another procedure, a catalyst powder, for example, is distributed onto the proton exchange membrane surface and integrated at an elevated temperature under pressure. If, however, the amount of catalyst powder exceeds about 2 mg/cm², the inclusion of a binder such as polytetrafluoroethylene is common. Further, the catalyst may be plated onto dispersed small support particles (e.g., the size 30 is typically between 20 and 200 Å, and more preferably between about 20 and 100 Å). This increases the catalyst surface area, which in turn increases the number of reaction sites leading to improved cell efficiency. In one such chemical plating method, for example, a powdery carrier material such as conductive carbon black is contacted with an aqueous solution or aqueous 35 suspension (slurry) of compounds of metallic components constituting the alloy to permit adsorption or impregnation of the metallic compounds or their ions on or in the carrier. Then, while the slurry is stirred at high speed, a dilute solution of suitable fixing agent such as ammonia, hydrazine, formic acid, or formalin is

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slowly added drop-wise to disperse and deposit the metallic components on the carrier as insoluble compounds or partly reduced fine metal particles.

[0106] The loading, or surface concentration, of a composition on the membrane or electrode is based in part on the desired power output and cost for a particular fuel cell. In general, power output increases with increasing concentration; however, there is a level beyond which performance is not improved. Likewise, the cost of a fuel cell increases with increasing concentration. Thus, the surface concentration of composition is selected to meet the application requirements. For example, a fuel cell designed to meet the requirements of a demanding application such as an extraterrestrial vehicle will usually have a surface concentration of the composition sufficient to maximize the fuel cell power output. For less demanding applications, economic considerations dictate that the desired power output be attained with as little of the composition as possible. Typically, the loading of composition is between about 0.01 and about 6 mg/cm². Experimental results to-date indicate that in some embodiments the composition loading is preferably less than about 1 mg/cm², and more preferably between about 0.1 and 1 mg/cm².

[0107] To promote contact between the collector, electrode, composition and membrane, the layers are usually compressed at high temperature. The 20 housings of the individual fuel cells are configured in such a way that a good gas supply is ensured, and at the same time the product water can be discharged properly. Typically, several fuel cells are joined to form stacks, so that the total power output is increased to economically feasible levels.

[0108] In general, the catalyst compositions and fuel cell electrodes of the present invention may be used to electrocatalyze any fuel containing hydrogen (e.g., hydrogen and reformed-hydrogen fuels). Also, hydrocarbon-based fuels may be used including: saturated hydrocarbons, such as methane (natural gas), ethane, propane and butane; garbage off-gas; oxygenated hydrocarbons, such as methanol and ethanol; fossil fuels, such as gasoline and kerosene; and, mixtures thereof.

[0109] To achieve the full ion-conducting property of proton exchange membranes, in some embodiments suitable acids (gases or liquids) are typically added to the fuel. For example, SO₂, SO₃, sulfuric acid, trifluoromethanesulfonic acid or the fluoride thereof, also strongly acidic carboxylic acids such as trifluoroacetic acid, and volatile phosphoric acid compounds may be used ("Ber. Bunsenges. Phys. Chem.", Volume 98 (1994), pages 631 to 635).

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6. Fuel Cell Uses

[0110] As set forth above, the compositions of the present invention are useful as catalysts in fuel cells that generate electrical energy to perform useful work. For example, the compositions may be used in fuel cells which are in:

5 electrical utility power generation facilities; uninterrupted power supply devices; extraterrestrial vehicles; transportation equipment, such as heavy trucks, automobiles, and motorcycles (see, Fuji et al., U.S. Pat. No. 6,048,633; Shinkai et al., U.S. Pat. No. 6,187,468; Fuji et al., U.S. Pat. No. 6,225,011; and Tanaka et al., U.S. Pat. No. 6,294,280); residential power generation systems; mobile

10 communications equipment such as wireless telephones, pagers, and satellite phones (see, Prat et al., U.S. Pat. No. 6,127,058 and Kelley et al., U.S. Pat. No. 6,268,077); mobile electronic devices such as laptop computers, personal data assistants, audio recording and/or playback devices, digital cameras, digital video cameras, and electronic game playing devices; military and aerospace equipment such as global positioning satellite devices; and, robots.

7. Definitions

[0111] Activity is defined as the maximum sustainable, or steady state, current (Amps) obtained from the electrocatalyst, when fabricated into an electrode, at a given electric potential (Volts). Additionally, because of differences in the geometric area of electrodes, when comparing different electrocatalysts, activity is often expressed in terms of current density (A/cm²).

[0112] An alloy may be described as a solid solution in which the solute and solvent atoms (the term solvent is applied to the metal that is in excess) are arranged at random, much in the same way as a liquid solution may be described. If some solute atoms replace some of those of the solvent in the structure of the latter, the solid solution may be defined as a substitutional solid solution. Alternatively, an interstitial solid solution is formed if a smaller atom occupies the interstices between the larger atoms. Combinations of the two types are also possible. Furthermore, in certain solid solutions, some level of regular arrangement may occur under the appropriate conditions resulting in a partial ordering that may be described as a superstructure. If long-range ordering of atoms occurs, the alloy may be described as crystallographically ordered, or simply ordered. These alloys may have characteristics that may be distinguishable through characterization techniques such as XRD. Significant changes in XRD may be apparent due to changes in symmetry. Although the

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global arrangement of the metal atoms may be similar in the case of a solid solution and an ordered alloy, the relationship between the specific locations of the metal A and metal B atoms is now ordered, not random, resulting in different diffraction patterns. Further, a homogeneous alloy is a single compound comprising the constituent metals. A heterogeneous alloy comprises an intimate mixture of individual metals and/or metal-containing compounds. An alloy, as defined herein, is also meant to include materials which may comprise elements which are generally considered to be non-metallic. For example, some alloys of the present invention may comprise oxygen and/or carbon in an amount that is generally considered to be a low or impurity level (see, e.g., Structural Inorganic Chemistry, A.F. Wells, Oxford University Press, 5th Edition, 1995, chapter 29).

8. EXAMPLES

<u>Example 1</u> - Forming Catalysts Compositions on Individually Addressable Electrodes

15 [0113] The catalyst compositions set forth in Tables A-O, infra, were prepared using the combinatorial techniques disclosed in Warren et al., U.S. Pat. No. 6,187,164; Wu et al., U.S. Pat. No. 6,045,671; Strasser, P., Gorer, S. and Devenney, M., Combinatorial Electrochemical Techniques For The Discovery of New Fuel-Cell Cathode Materials, Nayayanan, S.R., Gottesfeld, S. 20 and Zawodzinski, T., eds., Direct Methanol Fuel Cells, Proceedings of the Electrochemical Society, New Jersey, 2001, p. 191; and Strasser, P., Gorer, S. and Devenney, M., Combinatorial Electrochemical Strategies For The Discovery of New Fuel-Cell Electrode Materials, Proceedings of the International Symposium on Fuel Cells for Vehicles, 41st Battery Symposium, The 25 Electrochemical Society of Japan, Nagoya 2000, p. 153. For example, an array of independent electrodes (with areas of between about 1 and 3 mm²) was fabricated on inert substrates (e.g., glass, quartz, sapphire, alumina, plastics, and thermally treated silicon). The individual electrodes were located substantially in the center of the substrate, and were connected to contact pads 30 around the periphery of the substrate with wires. The electrodes, associated wires, and contact pads were fabricated from a conducting material (e.g., titanium, gold, silver, platinum, copper or other commonly used electrode materials).

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[0114] Specifically, the catalyst compositions set forth in Tables A-O were prepared using a photolithography/RF magnetron sputtering technique (GHz range) to deposit a thin film of the catalysts on arrays of 64 individually addressable electrodes. A quartz insulating substrate was provided and 5 photolithographic techniques were used to design and fabricate the electrode patterns on it. By applying a predetermined amount of photoresist to the substrate, photolyzing pre-selected regions of the photoresist, removing those regions that have been photolyzed (e.g., by using an appropriate developer), depositing a layer of titanium about 500 nm thick using RF magnetron sputtering over the entire surface and removing predetermined regions of the deposited titanium (e.g. by dissolving the underlying photoresist), intricate patterns of individually addressable electrodes were fabricated on the substrate.

[0115] Referring to Figure 4, the fabricated array 40 consisted of 64 individually addressable electrodes 41 (about 1.7 mm in diameter) arranged in 15 an 8 x 8 square that were isolated from each other (by adequate spacing) and from the substrate 44 (fabricated on an insulating substrate), and whose interconnects 42 and contact pads 43 were insulated from the electrochemical testing solution (by hardened photoresist or other suitable insulating material).

[0116] After the initial array fabrication and prior to deposition of the
20 catalysts for screening, a patterned insulating layer covering the wires and an inner portion of the peripheral contact pads was deposited, leaving the electrodes and the outer portion of the peripheral contact pads exposed (preferably approximately half of the contact pad is covered with this insulating layer). Because of the insulating layer, it is possible to connect a lead (e.g., a
25 pogo pin or an alligator clip) to the outer portion of a given contact pad and address its associated electrode while the array is immersed in solution, without having to worry about reactions that can occur on the wires or peripheral contact pads. The insulating layer was a hardened photoresist, but any other suitable material known to be insulating in nature could have been used (e.g., glass,
30 silica, alumina, magnesium oxide, silicon nitride, boron nitride, yttrium oxide, or titanium dioxide).

[0117] Following the creation of the titanium electrode array, a steel mask having 64 holes (1.7 mm in diameter) was pressed onto the substrate to prevent deposition of sputtered material onto the insulating resist layer. The deposition of the catalyst was also accomplished using RF magnetron sputtering and a two shutter masking system as described by Wu et al. which enable the deposition of material onto 1 or more electrodes at a time. Each individual thin film catalyst was created by a super lattice deposition method. For example,

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when preparing a catalyst composition consisting essentially of metals M1 and M2, each is deposited onto an electrode, and partially or fully alloyed with the other metals thereon. More specifically, first a metal M1 sputter target is selected and a thin film of M1 having a defined thickness is deposited on the 5 electrode. This initial thickness is typically from about 3 to about 12 Å. After this, metal M2 is selected as the sputter target and a layer of M2 is deposited onto the layer of M1. The thickness of M2 layer is also from about 3 to about 12 Å. The thicknesses of the deposited layers are in the range of the diffusion length of the metal atoms (e.g., about 10 to about 30 Å), which allows in-situ 10 alloying of the metals to form a M1-M2 alloy film. As a result of the two deposition steps, an alloy thin film (6 - 25 Å thickness) of the desired stoichiometry is created. This concludes one deposition cycle. In order to achieve the desired total thickness of a catalyst composition, deposition cycles are repeated as necessary which results in the creation of a super-lattice 15 structure of a defined total thickness (typically about 700 Å). Although the number, thickness (stoichiometry) and order of application of the individual metal layers may be determined manually, it is desirable to utilize a computer program to design an output file which contains the information necessary to control the operation of the sputtering device during the preparation of a particular library 20 wafer (i.e., array). One such computer program is the LIBRARY STUDIO software available from Symyx Technologies, Inc. of Santa Clara, California and described in European Patent No. 1080435 B1. The compositions of several as-sputtered alloys were analyzed using Electron Dispersive Spectroscopy (EDS) to confirm that they were consistent with desired compositions (chemical 25 compositions determined using EDS are within about 5% of the actual composition).

[0118] Arrays were prepared to evaluate the specific alloy compositions set forth in Tables A1-A10 and B-O, below. For the arrays of Tables A1-A10 and B-G, each had one electrode that consisted essentially of platinum, which served as an internal standard for the screening of the alloys on that array. For the arrays of Tables H-O, an internal platinum standard electrode was not present. Rather, these samples were evaluated against an external platinum standard comprising an array of 64 platinum electrodes (to determine the experimental error of the oxygen reduction test) in which the oxygen reduction activity of the 64 platinum electrodes averaged -0.75 mA/cm² at +0.1V vs. a mercury/mercury sulfate electrode.

Table A1

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- 1	Array .	Electrode	End Current	End Current	Relative	Pt	Cu
	Number	Number	Density	Density per	Activity		
		i i	(Absolute	Weight Fraction	Compared to		1
l			Activity)	of Pt	Internal Pt		
]	mA/cm ²	mA/cm ²		atomic %	atomic %
	133379	6	-0.48	-0.59	1.62	60	40
5	133379	27	-0.37	-0.49	1.24	50	50
	133379	30	-0.12	-0.27	0.40	20	80

Table A2

ſ	Array	Electrode	End Current	End Current	Relative	Pt	Cu
	Number	Number	Density	Density per	Activity		
			(Absolute	Weight	Compared to		
			Activity)	Fraction of Pt	Internal Pt]
			mA/cm ²	mA/cm ²		atomic %	atomic %
10	133802	8	-1.17	-1.43	1.58	60	40
	133802	35	-1.04	-1.47	1.41	44	56
	133802	40	-0.89	-0.97	1.21	80	20
	133802	51	-0.89	-1.04	1.20	67	33
	133802	3	-0.47	-1.01	0.64	22	78

15 Table A3

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	Array Number	Electrode Number	End Current Density	End Current Density per	Relative Activity Compared to	Pt	Cu
			(Absolute Activity) mA/cm²	Weight Fraction of Pt mA/cm ²	Internal Pt	atomic %	atomic %
ı	132991	27	-0.93	-1.23	1.55	50	50
	132991	6	-0.79	-0.96	1.32	60	40
20	132991	30	-0.23	-0.52	0.38	20	80

Table A4

ſ	Array	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Number	Density	Density per	Compared to		
			(Absolute	Weight Fraction	Internal Pt		
			Activity)	of Pt			1
			mA/cm ²	mA/cm ²		atomic %	atomic %
	134165	55	-1.41	-1.71	1.45	60	40
25	134165	64	-1.37	-1.67	1.42	60	40
	134165	63	-0.05	-0.11	0.05	20	80

Table A5

	Array	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Number	Density	Density per	Compared to		ì
			(Absolute	Weight Fraction	Internal Pt		
			Activity)	of Pt			
			mA/cm²	mA/cm²		atomic %	atomic %
	126556	6	-0.15	-0.18	1.44	60	40
5	126556	27	-0.13	-0.17	1.22	50	50
	126556	30	-0.05	-0.12	0.50	20	80

Table A6

	Array	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Number	Density	Density per	Compared to		1
			(Absolute	Weight Fraction	Internal Pt		
			Activity)	of Pt			·
			mA/cm ²	mA/cm ²		atomic %	atomic %
10	130758	8	-1.24	-1.51	1.39	60	40
	130758	35	-1.15	-1.62	1.29	44	56
	130758	51	-0.92	-1.07	1.03	67	33
	130758	40	-0.88	-0.95	0.99	80	20

Table A7

15	Array Number	Electrode Number	End Current Density (Absolute	End Current Density per Weight Fraction	Relative Activity Compared to Internal Pt	Pt	Cu
			Activity) mA/cm ²	of Pt mA/cm ²		atomic %	atomic %
	132971	27	-1.00	-1.32	1.34	50	50
	132971	6	-0.87	-1.06	1.17	60	40
	132971	30	-0.17	-0.38	0.22	20	80

20 Table A8

- 1	Array	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Number	Density	Density per	Compared to		İ
			(Absolute	Weight Fraction	Internal Pt		1
			Activity)	of Pt			
			mA/cm ²	mA/cm ²		atomic %	atomic %
	133815	35	-0.71	-1.00	1.08	45	55
	133815	51	-0.70	-0.81	1.06	67	33
25	133815	8	-0.67	-0.82	1.02	60	40
	133815	40	-0.64	-0.69	0.97	80	20
	133815	3	-0.10	-0.21	0.15	22	78

Table A9

1	Array	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Number	Density	Density per	Compared to		
			(Absolute	Weight Fraction	Internal Pt		
			Activity)	of Pt			
		_	mA/cm ²	mA/cm ²		atomic %	atomic %
	133352	35	-0.81	-1.14	1.03	44	56
5	133352	51	-0.79	-0.92	1.01	67	33
	133352	8	-0.73	-0.89	0.93	60	40
	133352	40	-0.72	-0.78	0.92	80	20
	133352	3	-0.37	-0.79	0.47	22	78

Table A10

10	Array	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Number	Density	Density per	Compared to		
			(Absolute	Weight Fraction	Internal Pt		, ,
			Activity)	of Pt]
			mA/cm ²	mA/cm ²		atomic %	atomic %
	133803	40	-0.81	-0.88	1.07	80	20
	133803	35	-0.78	-1.09	1.02	44	56
	133803	51	-0.76	-0.88	1.00	67	33
15	133803	8	-0.74	-0.90	0.98	60	40
	133803	3	-0.10	-0.20	0.13	22	78

Table B

ſ	Array	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Number	Density	Density per	Compared to		
			(Absolute	Weight Fraction	Internal Pt		
ı,	•		Activity)	of Pt			
			mA/cm ²	mA/cm ²		atomic %	atomic %
20	136300*	1	-4.05	-7.30	6.46	29	71
	136300*	2	-3.83	-6.52	6.11	32	68
	136300*	3	-3.20	<i>-</i> 5.13	5.11	35	65
	136300*	4	-2.02	-3.04	3.23	39	61
	136299	1	-1.16	-2.10	1.35	29	71
25	136299	2	-1.14	-1.95	1.33	32	68
	136300*	7	-0.79	-0.95	1.26	62	38
	136300*	5	-0.74	-1.04	1.19	45	55
	136300*	6	-0.74	-0.97	1.19	52	48
	137656	49	-0.58	-0.71	1.17	60	40
30	136299	3	-0.98	-1.57	1.14	35	65
	137564	49	-0.62	-0.76	1.10	60	40
	136299	7	-0.93	-1.12	1.08	62	38
	136299	4	-0.92	-1.38	1.07	39	61
	136299	5	-0.90	-1.26	1.04	45	55
35	136299	6	-0.90	-1.17	1.04	52	48
	137674	49	-0.24	-0.30	0.80	60	40

^{*} Array 136300 was heated to about 400 °C for about 12 hours in vacuum prior to being screened in attempts to mimic powder synthesis.

Table C [Lib. 139107]

Ī	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Density (Absolute	Density per	Compared to		
		Activity)	Weight Fraction	Internal Pt		
			of Pt			
		mA/cm²	mA/cm ²		atomic %	atomic %
5	31.	-4.33	-9.96	6.40	20	80
	23	-1.25	-2.19	1.84	30	70
	55	-0.86	-1.29	1.28	40	60
	28	-0.85	-1.27	1.26	40	60
	56	-0.83	-0.86	1.22	90	10
10	50	-0.70	-0.79	1.03	70	30
	47	-0.69	-0.91	1.02	50	50
,	26:	-0.69	-0.91	1.01	50	50
	42	-0.68	-0.74	1.01	80	20
	48	-0.68	-0.68	1.00	100	0
15	20 .	-0.67	-0.89	1.00	50	50
	52	-0.67	-0.82	1.00	60	40
	44.	-0.64	-0.73	0.95	70	30
	18:	-0.63	-0.76	0.93	60	40
	24.	-0.62	-0.67	0.92	80	20
20	32	-0.61	-0.69	0.90	70	30

Table D [Lib. 140044]

	Electrode	End Current	End Current	Relative Activity	Pt	Cu
25	Number	Density (Absolute	Density per	Compared to		
	•	Activity)	Weight Fraction	Internal Pt		
			of Pt			
		mA/cm ²	mA/cm ²		atomic %	atomic %
	23	-1.81	-3.19	3.16	30	70
	42	-0.81	-0.88	1.42	80	20
	24	-0.78	-0.84	1.35	80	20
	56	-0.70	-0.72	. 1.21	90	10
30	44.	-0.68	-0.78	1.19	70	30
	52	-0.67	-0.82	1.17	60	40
	18	-0.64	-0.77	1.11	60	40
	47	-0.62	-0.82	1.07	50	50
	50	-0.61	-0.70	1.07	70	30
35	32	-0.60	-0.69	1.05	70	30
	48	-0.57	-0.57	1.00	100	0
	20	-0.55	-0.74	0.97	50	50
	26	-0.53	-0.70	0.91	50	50
	28	-0.49	-0.72	0.85	40	60
40	55	-0.47	-0.70	0.82	40.	60

Table E [Lib. 140150]

1	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Density (Absolute	Density per	Compared to		1
		Activity)	Weight Fraction	Internal Pt		{
			of Pt			
		mA/cm ²	mA/cm ²		atomic %	atomic %
5	23	-2.59	-4.56	2.05	30	70
	31	-2.06	-4.74	1.63	20	80
	55	-1.52	-2.26	1.20	40	60
	28	-1.51	-2.24	1.19	40	60
	26	-1.40	-1.86	1.11	50	50
10	47	-1.39	-1.84	1.10	50	50
	56	-1.36	-1.41	1.08	90	10
	42	-1.36	-1.47	1.08	80	20
	20	-1.35	-1.79	1.07	50	50
	52	-1.35	-1.64	1.07	60	40
15	24	-1.29	-1.40	1.02	80	20
	48	-1.26	-1.26	1.00	100	0
	32	-1.26	-1.43	1.00	70	30
	18	-1.23	-1.50	0.98	60	40
	44	-1.20	-1.36	0.95	70	30
20	50	-1.19	-1.36	0.94	70	30

Table F [Lib. 141101]

ſ	Electrode	End Current	End Current	Relative Activity	Pt	Cu
	Number	Density (Absolute	Density per	Compared to		
l		Activity)	Weight Fraction	Internal Pt		i i
			of Pt			
1		mA/cm²	mA/cm ²		atomic %	atomic %
25	23	-2.13	-3.74	26.65	30	70
	28	-0.43	-0.63	5.35	40	60
	55	-0.39	-0.58	4.92	40	60
1	47.	-0.32	-0.42	3.99	50	50
	24	-0.28	-0.30	3.50	80	20
30	26.	-0.27	-0.36	3.41	50	50
	20	-0.26	-0.34	3.26	50	50
	50	-0.25	-0.29	3.14	70	30
	42	-0.23	-0.25	2.92	80	_ 20
	44	-0.22	-0.26	2.81	70	30
35	52	-0.22	-0.26	2.71	60	40
	32	-0.22	-0.25	2.70	70	30
	18	-0.21	-0.25	2.58	60	40
	56	-0.19	-0.20	2.43	90	10
	48	-0.08	-0.08	1.00	100	0

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Table G [Lib. 141477]

Г	Electrode	End Current	End Current	Relative Activity	Pt	Cu
1	Number	Density (Absolute	Density per	Compared to		
		Activity)	Weight Fraction	Internal Pt		
L			of Pt			
_ [mA/cm²	mA/cm²		atomic %	atomic %
5	48	-4.31	-9.99	2.95	19.82	80.18
L	56	-4.24	-9.81	2.90	19.82	80.18
L	40	-4.18	-9.68	2.86	19.82	80.18
L	64	-3.94	-9.14	2.70	19.82	80.18
	8	-3.68	-8.54	2.52	19.82	80.18
10	16	-3.65 .	-8.45	2.50	19.82	80.18
L	32	-3.32	-7.70	2.28	19.82	80.18
	24	-3.27	-7.58	2.24	19.82	80.18
	47	-2.71	-5.00	1.85	27.77	72.23
	31	-2.25	-4.15	1.54	27.77	72.23
15 [39	-2.13	-3.93	1.46	27.77	72.23
	6	-1.92	-3.00	1.32	36.58	63.42
	14	-1.91	-2.99	1.31	36.58	63.42
[54	-1.90	-2.97	1.30	36.58	63.42
	22	-1.85	-2.89	1.27	36.58	63.42
20 [46	-1.81	-2.83	1.24	36.58	63.42
	62	-1.80	-2.81	1.23	36.58	63.42
	30	-1.77	-2.78	1.22	36.58	63.42
[15	-1.74	-3.22	1.20	27.77	72.23
	38.	-1.70	-2.67	1.17	36.58	63.42
25	18,	-1.61	-1.72	1.11	83.85	16.15
	35	-1.61	-1.84	1.10	69.76	30.24
	23	-1.60	-2.96	1.10	27.77	72.23
	27	-1.60	-1.83	1.10	69.76	30.24
	7	-1.59	-2.93	1.09	27.77	72.23
30	45	-1.59	-2.18	1.09	46.38	53.62
	43,	-1.58	-1.80	1.08	69.76	30.24
	37.	-1,57	-2.16	1.08	46.38	53.62
	55	-1.57	-2.89	1.07	27.77	72.23
	51	-1.55	-1.77	1.06	69.76	30.24
35	5	-1.54	-2.12	1.06	46.38	53.62
	28	-1.53	-1.90	1.05	57.37	42.63
	36	-1.53	-1.90	1.05	57.37	42.63
	50.	-1.53	-1.62	1.04	83.85	16.15
	19	-1.52	-1.74	1.04	69.76	30.24
40	34	-1.52	-1.62	1.04	83.85	16.15
	13	-1.51	-2.08	1.04	46.38	53.62
	10.	-1.51	-1.61	1.04	83.85	16.15
	53	-1.51	-2.08	1.03	46.38	53.62
	44	-1.50	-1.86	1.03	57.37	42.63
45	60	-1.50	-1.86	1.03	57.37	42.63
	20	-1.49	-1.86	1.02	57.37	42.63
	61	-1.49	-2.05	1.02	46.38	53.62
	52.	-1.48	-1.84	1.01	57.37	42.63
	2	-1.47	-1.56	1.01	83.85	16.15
50	4	-1.47	-1.82	1.01	57.37	42.63
	11	-1.47	-1.67	1.01	69.76	30.24
	9	-1.46	-1.46	1.00	100	0

Table H [Lib. 142776]

	Electrode Number	End Current Density (Absolute Activity)	End Current Density per Weight Fraction of	Pt	Cu
		mA/cm²	mA/cm²	atomic %	atomic %
	8	-1.79	-3.54	25.04	74.96
5	16	-2.07	-4.09	25.04	74.96
	24	-1.36	-2.39	30.06	69.94
	32	-1.37	-2.41	30.06	69.94
	40	-1.10	-1.76	35.07	64.93
	48	-1.58	-2.54	35.07	64.93
10	56	-1.08	-1.60	40.1	59.9
	64	-1.27	-1.89	40.1	59.9

Table I [Lib. 142767]

15	Electrode Number	End Current Density (Absolute Activity)	End Current Density per Weight Fraction of Pt	Pt	Cu
		mA/cm ²	mA/cm ²	atomic %	atomic %
	8	-1.58	-3.13	25.04	74.96
	16	-1.40	-2.76	25.04	74.96
	24	-0.92	-1.62	30.06	69.94
	32	-0.86	-1.52	30.06	69.94
20	40	-0.69	-1.11	35.07	64.93
	48	-0.71	-1.14	35.07	64.93
	56	-0.68	-1.01	40.1	59.9
	64.	-0.68	-1.01	40.1	59.9

Table J

25 [Lib. 142766]

	Electrode Number	End Current Density (Absolute Activity)	End Current Density per Weight Fraction of Pt	Pt	Cu
		mA/cm ²	mA/cm ²	atomic %	atomic %
	8	-1.93	-3.82	25.04	74.96
	16	-1.42	-2.81	25.04	74.96
	24	-1.20	-2.12	30.06	69.94
30	32	-1 <i>.</i> 16	-2.04	30.06	69.94
	40	-0.89	-1.42	35.07	64.93
	48	-0.97	-1.56	35.07	64.93
	56	-0.89	-1.32	40.1	59.9
	64	-0.86	1.28	40.1	59.9

Table K [Lib. 142716]

	Electrode Number	End Current Density (Absolute Activity)	End Current Density per Weight Fraction of	Pt	Cu
			Pt		
		mA/cm²	mA/cm ²	atomic %	atomic %
	8	-2.81	-5.54	25.04	74.96
5	16	-2.73	-5.40	25.04	74.96
	24	-1.25	-2.20	30.06	69.94
	32	-1.25	-2.20	30.06	69.94
	40	-0.95	-1.52	35.07	64.93
	48	-0.97	-1.55	35.07	64.93
10	56	-1.08	-1.60	40.1	59.9
	64	-0.99	-1.47	40.1	59.9

Table L [Lib. 142715]

	Electrode Number	End Current Density	End Current Density	Pt	Cu
		(Absolute Activity)	per Weight Fraction of Pt		
		mA/cm ²	mA/cm²	atomic %	atomic %
15	8.	-1.28	-2.53	25.04	74.96
	16	-1.18	-2.33	25.04	74.96
	24	-0.95	-1.67	30.06	69.94
	32	-0.88	-1.55	30.06	69.94
	40	-0.67	-1.08	35.07	64.93
20	48	-0.71	-1.14	35.07	64.93
	56	-0.64	-0.96	40.1	59.9
	64	-0.73	-1.09	40.1	59.9

Table M [Lib. 142714]

			-		
25	Electrode Number	End Current Density (Absolute Activity)	End Current Density per Weight Fraction of Pt	Pt	Cu
		mA/cm²	mA/cm ²	atomic %	atomic %
	8	-1.06	-2.10	25.04	74.96
	16	-1.28	-2.52	25.04	74.96
	24	-1.30	-2.28	30.06	69.94
	32,	-1.54	-2.70	30.06	69.94
30	40	-0.96	-1.54	35.07	64.93
	48	-1.29	-2.06	35.07	64.93
	56	-0.88	-1.31	40.1	59.9
	64	-0.96	-1.42	40.1	59.9

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Table N [Lib. 142713]

	Electrode Number	End Current Density (Absolute Activity)	End Current Density per Weight Fraction of	Pt	Cu
		mA/cm²	mA/cm ²	atomic %	atomic %
	8.	-1.28	-2.53	25.04	74.96
5	16	-1.16	-2.29	25.04	74.96
	24	-0.69	-1.21	30.06	69.94
	32	-0.86	-1.52	30.06	69.94
	40	-0.44	-0.70	35.07	64.93
	48	-0.49	-0.78	35.07	64.93
10	56	-0.40	-0.60	40.1	59.9
	64	-0.45	-0.67	40.1	59.9

Table O [Lib. 142700]

	Electrode Number	End Current Density (Absolute Activity)	End Current Density per Weight Fraction of Pt	Pt	Cu
		mA/cm²	mA/cm²	atomic %	atomic %
15	8	-1.22	-2.41	25.04	74.96
	16	-1.03	-2.03	25.04	74.96
	24	-0.67	-1.18	30.06	69.94
	32	-0.75	-1.33	30.06	69.94
	40	-0.46	-0.75	35.07	64.93
20	48	-0.61	-0.97	35.07	64.93
	56	-0.52	-0.78	40.1	59.9
	64	-0.61	-0.91	40.1	59.9

Example 2 - Screening Alloys for Electrocatalytic Activity

[0119] The catalyst compositions set forth in Tables A1-A10 and B that were synthesized on arrays according to the method set forth in Example 1 were screened for electrochemical reduction of molecular oxygen to water according to Protocol 1 (detailed below), to determine relative electrocatalytic activity against the internal and/or external platinum standard. Additionally, the catalyst compositions set forth in Tables C-O that were synthesized on arrays according to the method set forth in Example 1 were screened for electrochemical reduction of molecular oxygen to water according to Protocol 2 (detailed below), to determine relative electrocatalytic activity.

[0120] In general, the array wafers were assembled into an electrochemical screening cell and a screening device established an electrical contact between the 64 electrode catalysts (working electrodes) and a 64-channel potentiostat used for the screening. Specifically, each wafer array

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was placed into a screening device such that all 64 spots were facing upward and a tube cell body that was generally annular and having an inner diameter of about 2 inches (5 cm) was pressed onto the upward facing wafer surface. The diameter of this tubular cell was such that the portion of the wafer with the square electrode array formed the base of a cylindrical volume while the contact pads were outside the cylindrical volume. A liquid ionic solution (i.e., 0.5 M H₂SO₄ aqueous electrolyte) was poured into this cylindrical volume, and a common counter electrode (i.e., platinum gauze) and a common reference electrode (e.g., mercury/mercury sulfate reference electrode (MMS)) were placed into the electrolyte solution to close the electrical circuit.

[0121] A rotator shaft with blades was placed into the electrolyte to provide forced convection-diffusion conditions during the screening. The rotation rate was typically between about 300 to about 400 rpm. Depending on the screening experiment, either argon or pure oxygen was bubbled through the electrolyte during the measurements. Argon served to remove O₂ gas in the electrolyte to simulate O₂-free conditions used for the initial conditioning of the catalysts. The introduction of pure oxygen served to saturate the electrolyte with oxygen for the oxygen reduction reaction. During the screening, the electrolyte was maintained at 60 °C and the rotation rate was constant.

[0122] Protocol 1: Three groups of tests were performed to screen the activity of the catalysts. The electrolyte was purged with argon for about 20 minutes prior to the electrochemical measurements. The first group of tests comprised cyclic voltammetric measurements while purging the electrolyte with argon. Specifically, the first group of tests comprised:

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- a potential sweep from open circuit potential (OCP) to about +0.3
 V to about -0.63 V and back to about +0.3 V at a rate of about 20 mV/s;
- b. seventy-five consecutive potential sweeps from OCP to about +0.3
 V to about -0.7 V and back to about +0.3 V at a rate of about 200 mV/s; and
- c. a potential sweep from OCP to about +0.3 V to about -0.63 V and back to about +0.3 V at a rate of about 20 mV/s.

The shape of the cyclic voltammetric (CV) profile of the internal Pt standard catalyst as obtained in test (c) was compared to an external standard CV profile obtained from a Pt thin film electrode that had been pretreated until a stable CV was obtained. If test (c) resulted in a similar cyclic voltammogram, the first group of experiments was considered completed. If the shape of the cyclic voltammogram of test (c) did not result in the expected standard Pt CV behavior,

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tests (b) and (c) were repeated until the Pt standard catalyst showed the desired standard voltammetric profile. In this way, it was ensured that the Pt standard catalyst showed a stable and well-defined oxygen reduction activity in subsequent experiments. The electrolyte was then purged with oxygen for approximately 30 minutes. The following second group of tests was performed while continuing to purge with oxygen:

- a. measuring the open circuit potential (OCP) for a minute; then, the potential was stepped to -0.4 V, held for a minute, and was then swept up to about +0.4 V at a rate of about 10 mV/s;
- b. measuring the OCP for a minute; then applying a potential step from OCP to about +0.1 V while measuring the current for about 5 minutes; and
 - c. measuring the OCP for a minute; then applying a potential step from OCP to about +0.2 V while monitoring the current for about 5 minutes.

The third group of tests comprised a repeat of the second group of tests after about one hour from completion of the second group of tests. The electrolyte was continually stirred and purged with oxygen during the waiting period. All the foregoing test voltages are with reference to a mercury/mercury sulfate (MMS) electrode. Additionally, an external platinum standard comprising an array of 64 platinum electrodes was used to monitor the tests to ensure the accuracy and consistency of the oxygen reduction evaluation.

[0123] Protocol 2: Four groups of tests were performed to screen the activity of the catalysts. The first group is a pretreatment process, whereas the other three groups are identical sets of experiments in order to screen the oxygen reduction activity as well as the current electrochemical surface area of the catalysts. The electrolyte was purged with argon for about 20 minutes prior to the electrochemical measurements. The first group of tests comprised cyclic voltammetric measurements while purging the electrolyte with argon.

30 Specifically, the first group of tests comprised:

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- a.: a potential sweep from open circuit potential (OCP) to about +0.3
 V to about -0.63 V and back to about +0.3 V at a rate of about 20 mV/s;
- fifty consecutive potential sweeps from OCP to about +0.3 V to about -0.7 V and back to about +0.3 V at a rate of about 200 mV/s; and
 - c. a potential sweep from OCP to about +0.3 V to about -0.63 V and back to about +0.3 V at a rate of about 20 mV/s.

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After step (c) of the first group of tests, the electrolyte was purged with oxygen for approximately 30 minutes. Then, the following second group of tests was performed, which comprised a test in an oxygen-saturated solution (i.e., test (a)), followed by a test performed in an Ar-purged (i.e., an oxygen-free solution, 5 test (b)):

- in an oxygen-saturated solution, the OCP was measured for a minute; a potential step was then applied from OCP to about -0.4
 V; this potential was held for approximately 30 seconds, and then the potential was stepped to about +0.1 V while measuring the current for about 5 minutes; and
- b. after purging the electrolyte with Ar for approximately 30 minutes, a potential sweep was performed from open circuit potential (OCP) to about +0.3 V to about -0.63 V and back to about +0.3 V, at a rate of about 20 mV/s.
- 15 The third and fourth group of tests comprised a repeat of the second group of tests after completion. All the foregoing test voltages are with reference to a mercury/mercury sulfate (MMS) electrode. Additionally, an external platinum standard comprising an array of 64 platinum electrodes was used to monitor the tests to ensure the accuracy and consistency of the oxygen reduction evaluation.

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- [0124] The specific catalyst compositions set forth in Tables A1-A10 and B-O were prepared and screened in accordance with the above-described methods of Protocols 1 (Tables A1-A10 and B) or 2 (Tables C-O), and the test results are set forth therein. The screening results in Tables A1-A10 and B are for the third test group (steady state currents at +0.1 V MMS). The screening results in Tables C-G were taken from the oxygen reduction measurements of the fourth group of tests (i.e., the last screening in an oxygen-saturated solution), the Ar-saturated steps serving as an evaluation of additional catalyst-related parameters, such as surface area over time.
- 30 [0125] The current value reported (End Current Density) is the result of averaging the last three current values of the chronoamperometric test normalized for geometric surface area. It is to be noted, from the results presented in these Tables, that numerous compositions exhibited an oxygen reduction activity which exceeded, for example, the internal platinum standard (see, e.g., the catalyst compositions in Tables A1-A10 and B-F having a "Relative Activity Compared to Internal Pt" in excess of 1.00; see also the catalyst compositions corresponding to Electrode Numbers, for example: 48, 56, 40, 64, 8, 16, 32, 24, 47, 31, 39, 6, 14, 54, 22, 46, 62, 30, 15, 38, 18, 35, 23, 27,

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7 and 45 in Table G; internal platinum standards were not present for Tables H-O).

Example 3 - Synthesis of Supported Catalysts

[0126] The synthesis of Pt-Cu catalyst compositions (see Tables P and Q, Target Catalyst Comp., infra) on carbon support particles was attempted according to different method conditions, in order to evaluate the performance of the catalysts while in a state that is typically used in fuel cell. To do so, the catalyst component were deposited or precipitated on supported platinum powder (i.e., platinum nanoparticles supported on carbon black particles).

10 Platinum supported on carbon black is commercially available from companies such as Johnson Matthey, Inc., of New Jersey and E-Tek Div. of De-Nora, N.A., Inc., of Somerset, New Jersey. Such supported platinum powder is available with a wide range of platinum loading. The supported platinum powder used in this Example had a nominal platinum loading of about 20 or about 40 percent by 15 weight, a platinum surface area of between about 150 and about 170 m²/g (determined by CO adsorption), a combined carbon and platinum surface area between about 350 and about 400 m²/g (determined by N₂ adsorption), and an average particle size of less than about 0.5 mm (determined by sizing screen).

[0127] The catalyst compositions of Table P and Q (infra) were formed 20 on carbon support particles using a freeze-drying precipitation method. The freeze-drying method comprised forming an initial solution comprising the desired metal atoms in the desired concentrations. Each of the supported catalysts was prepared in an analogous manner, with variations in the amounts of metal-containing compounds used therein. For example, to prepare the 25 target Pt₂₅Cu₇₅ catalyst composition (HFC 344), having a final target platinum loading of about 16.2 percent by weight, 0.143 g of Cu(NO₃)₂•3H₂O was dissolved in a vial containing about 5 ml of H₂O. This solution was then introduced into a HDPE vial containing 0.200 g of supported platinum powder, which had a nominal platinum loading of about 19.2 percent by weight, resulting 30 in the formation of a black suspension. The suspension was homogenized by immersing a probe of a BRANSON SONIFIER 150 into the vial and sonicating the mixture for about 90 seconds at a power level of 3. The vial containing the homogenized suspension was then immersed in a liquid nitrogen bath for about 3 minutes to solidify the suspension. The solid suspension was then freezeWO 2005/024982 52 PCT/US2004/026847

dried for about 24 hours using a LABCONCO FREEZE DRY SYSTEM (Model 79480) to remove the solvent. The tray and the collection coil of the freeze dryer were maintained at about 27°C and about -49°C, respectively, while evacuating the system (the pressure was maintained at about 0.05 mbar).

5 During the final 2.5 hrs of the freeze-drying procedure, the shelve heater was set to 40°C. After completing the freeze-drying procedure, the vial contained a powder comprising the supported platinum powder, and the copper deposited thereon.

[0128] The recovered powders were then subjected to a heat treatment to reduce the constituents therein to their metallic state, and to fully or partially alloy the copper and the platinum on the carbon black particles. The heat treatment comprised heating the powder in a quartz flow furnace with an atmosphere comprising about 6% H₂ and 94% Ar using a temperature profile of room temperature to about 90°C at a rate of about 5°C/min; holding at about 90°C for 2 hours; increasing the temperature to about 200°C at a rate of 5°C/minute; holding at about 200°C for two hours; increasing the temperature at a rate of about 5°C/minute to a maximum temperature of, for example, about 500, 600, 700, 800, 900 or 950°C; holding at the maximum for a duration of about 1.2, 2, 3, 5, 7, 10, or even 12 hours (as indicated in Table P and Q); and, the cooling down to room temperature.

[0129] In order to determine the actual composition of the supported catalysts, the differently prepared catalysts (e.g., by composition variation or by heat treatment variation) were subjected to EDS (Electron Dispersive Spectroscopy) elemental analysis. For this technique, the sample powders were compressed into 6 mm diameter pellets with a thickness of about 1 mm. The target composition and actual composition for certain of the supported catalyst prepared as described herein are set forth in Table P and Q.

Table P

		Т		Т	Т	Т	Т	Т							-				
electro- chemical surface area [cm2]																			
Approx. particle size (Å)	19	23	33	26	26	25	23	34	28	27	25	23	22	31	28	26	24	23	22
Lattice parameter (Å)	3.942	3.763	3.763	3.714	3.763	3.795	3.790	3.705	3.718	3.723	3.738	3.765	3.783	3.702	3.708	3.722	3.738	3.763	3.784
Catalyst Mass Activity at +0.15 V MMS (mA/mq)	48.7	77.7	52.8	75.2	57.3	51.3	52.0	58.6	58.4	74.8	111.3	73.2	76.6	69.5	9:69	101.1	93.2	98.9	92.1
Relative activity at +0.15 V MMS	1.00	3.51	2.38	3.60	2.66	2.28	2.27	3.18	2.98	3.63	5.57	3.34	3.42	3.77	3.56	5.30	4.36	4.52	4.11
Pt Mass Activity at +0.15 V MMS (mA/mg	128.8	ı	1	•		•	•	,	1		718.1	,	•	_		683.0		,	,
Measured Pt Loading (wt%)	37.8	•	•	•		•	-		•		15.5	1	•	2	3	14.8	,		ı
Target Pt Loading (wt%)	37.8	17.2	17.2	16.2	16.7	17.5	17.8	14.3	15.2	16.0	16.6	17.0	17.4	14.3	15.2	16.0	16.6	17.0	17.4
Actual Catalyst Comp.	ă				•	•	,	,			Pt. Cue	3				Pt.,Cu.,			•
Max Alloying Temp for a duration	0/1113/	7/00/	900 / 2	7/00/	7/007	7/007	7/00/	7/007	7/00/	7/007	7/007	7/007	2/002	2/009	2/009	2/009	600 / 7	600 / 7	2 / 009
Target Catalyst Comp.	ā	Pt.Cus	Pt.Cuer	Pt.Cu.	Pt.Cu.	Pt.Cu.	Pt.Cue	Pt.Cus.	PfaCile	Pf.Cit.	PfCu.	Pf.Cur.	Pt.Cu.	Pt. Cile.		Pt.C.I.	Pt. Cil.	1.0.1d	Pt, Cue
Powder	ç	287	290	344	345	346	347	360	361	363	363	364	365	367	368	369	37.0	371	372

_			$\overline{}$					-				_	_			
							1.05									
17	27	29	16	15	33	29	23	23	24	21	24	24	26	27	23	25
3.785	3.756	3.732	3.793	3.811	3.743	3.765	3.729	3.730	3.744	3.760	3.770	3.732	3.734	3.742	3.764	3.776
73.9	62.0	46.3	42.9	36.4	28.3	49.5	108.9	117.9	87.2	76.5	79.1	87.4	74.0	95.2	88.2	82.2
3.83	1.92	1.36	2.29	1.88	0.88	1.46	5.60	90.9	4.08	3.53	3.61	4.24	3.48	4.45	4.07	3.75
,	ı	1.	ı	•	-	•	721.5	780.8		•	1	a	•	•	J	
•	•	,	•	3	1		15.1	15.1		•		,	•	•	•	1
15.0	25.0	26.4	14.5	15.0	25.0	26.4	16.0	16.5	16.6	16.8	17.0	16.0	16.5	16.6	16.8	17.0
	,	•	,				Pt,Cu,	Pt, Cues				1	,	,		,
600 / 7	600 / 7	2/009	500 / 7	500 / 7	500 / 7	500 / 7	2/009	2/009	2/009	2/009	2/009	7/00/	7/00/	7/00/	7/007	7/007
Pf. Cit.	0,50% d	Pf.,Cu.,	Pt.Cu.	Pt, Cu,	Pt.Cu.	Pt, Cu,	Pt.Cu.	Pt., Cu.,	Pt.,Cu.,	Pt., Cur.	Pt.Cue	Pt.Cur	Pt., Cu.,	Pt.,Cu.,	Pt., Curr	Pt _s Cu ₆₅
375	376	377	378	379	380	381	382	383	384	385	386	387	388	389	390	391
	PF_CIL_ 600 / 7 - 15.0 - 3.83 73.9 3.785	Pt _{so} Cu ₇₀ 600 / 7 - 15.0 - 3.83 73.9 3.785	Pt ₃₀ Cu ₇₀ 600 / 7 - 15.0 - - 3.83 73.9 3.785 Pt ₂₀ Cu ₇₀ 600 / 7 - 25.0 - 1.92 62.0 3.756 Pt ₂₀ Cu ₇₀ 600 / 7 - 26.4 - 1.36 46.3 3.732	Pt ₂₀ Cu ₇₀ 600 / 7 - 15.0 - - 3.83 73.9 3.785 Pt ₂₀ Cu ₇₀ 600 / 7 - 25.0 - 1.92 62.0 3.756 Pt ₂₀ Cu ₇₀ 600 / 7 - 26.4 - - 46.3 3.732 Pt ₅ Cu ₇₀ 500 / 7 - 14.5 - - 2.29 42.9 3.793	Pt ₂₀ Cu ₇₅ 600 / 7 - 15.0 - - 3.83 73.9 3.785 Pt ₂₀ Cu ₇₅ 600 / 7 - 25.0 - 1.92 62.0 3.756 Pt ₂₀ Cu ₇₀ 600 / 7 - 26.4 - - 1.36 46.3 3.732 Pt ₂₀ Cu ₇₀ 500 / 7 - 14.5 - - 2.29 42.9 3.793 Pt ₀ Cu ₇₀ 500 / 7 - 15.0 - - 1.88 36.4 3.811	Pt ₃₅ Cu ₇₅ 600 / 7 - 15.0 - - 3.83 73.9 3.785 Pt ₂₅ Cu ₇₆ 600 / 7 - 25.0 - - 1.92 62.0 3.756 Pt ₂₅ Cu ₇₆ 600 / 7 - 26.4 - - 1.36 46.3 3.732 Pt ₂₅ Cu ₇₆ 500 / 7 - 14.5 - - 2.29 42.9 3.793 Pt ₂₅ Cu ₇₆ 500 / 7 - 15.0 - - 1.88 36.4 3.811 Pt ₅ Cu ₇₇ 500 / 7 - 25.0 - - 0.88 28.3 3.743	Pł ₂₀ Cu ₇₅ 600 / 7 - 15.0 - - 3.83 73.9 3.785 Pł ₂₀ Cu ₇₆ 600 / 7 - 25.0 - 1.92 62.0 3.785 Pł ₂₀ Cu ₇₆ 600 / 7 - 26.4 - - 1.36 46.3 3.732 Pł ₂₀ Cu ₇₆ 500 / 7 - 14.5 - - 2.29 42.9 3.793 Pł ₂₀ Cu ₇₆ 500 / 7 - 15.0 - - 1.88 36.4 3.811 Pł ₂₀ Cu ₇₆ 500 / 7 - 25.0 - - 0.88 28.3 3.743 Pł ₂₀ Cu ₇₆ 500 / 7 - 26.4 - - 1.46 49.5 3.765	Pt ₃₀ Cu ₇₅ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt ₃₀ Cu ₇₀ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt ₃₀ Cu ₇₀ 600 / 7 - 26.4 - - 1.36 46.3 3.732 29 27 Pt ₂₅ Cu ₇₅ 500 / 7 - 14.5 - - 2.29 42.9 3.793 16 15 Pt ₂₅ Cu ₇₅ 500 / 7 - 15.0 - - 1.88 36.4 3.811 15 Pt ₂₅ Cu ₇₅ 500 / 7 - 25.0 - - 0.88 28.3 3.743 33 Pt ₂₅ Cu ₇₅ 500 / 7 - 26.4 - - - 0.88 28.3 3.743 37 Pt ₂₅ Cu ₇₅ 600 / 7 Pt ₂ Cu ₇₅ 16.0 15.1 721.5 5.60 108.9 3.729 23	Pt ₃₀ Cu ₇₀ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt ₃₀ Cu ₇₀ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt ₃₀ Cu ₇₀ 600 / 7 - 26.4 - - 1.36 46.3 3.732 29 Pt ₃₀ Cu ₇₀ 500 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt ₃₀ Cu ₇₀ 500 / 7 - 15.0 - - 0.88 28.3 3.743 33 Pt ₃₀ Cu ₇₀ 500 / 7 - 26.4 - - 1.46 49.5 3.765 29 Pt ₃₀ Cu ₇₀ 600 / 7 Pt ₃₀ Cu ₇₀ 16.0 15.1 721.5 5.60 108.9 3.730 23 Pt ₂₅ Cu ₇₅ 600 / 7 Pt ₃₀ Cu ₇₀ 16.5 15.1 780.8 6.06 117.9 3.730 23	$P_{t_0}CU_{v_0}$ $600/7$ - 15.0 - - 3.83 73.9 3.785 17 $P_{t_0}CU_{v_0}$ $600/7$ - 25.0 - - 1.92 62.0 3.756 27 $P_{t_0}CU_{v_0}$ $600/7$ - 26.4 - - 1.36 46.3 3.793 16 $P_{t_0}CU_{v_0}$ $600/7$ - 14.5 - - 2.29 42.9 3.793 16 $P_{t_0}CU_{v_0}$ $500/7$ - 15.0 - - 1.88 36.4 3.811 15 $P_{t_0}CU_{v_0}$ $500/7$ - 25.0 - - 0.88 28.3 3.743 3.743 $P_{t_0}CU_{v_0}$ $500/7$ $ 25.0$ - $ 1.46$ 49.5 3.765 2.9 $P_{t_0}CU_{v_0}$ $500/7$ $ 25.4$ $ -$ <t< td=""><td>Pt₂₀CU₁₀ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt₂₀CU₁₀ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt₂₀CU₁₀ 600 / 7 - 26.4 - - 1.36 46.3 3.732 29 Pt₂₀CU₁₀ 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt₂₀CU₁₀ 500 / 7 - 14.5 - - 1.88 36.4 3.811 15 Pt₂₀CU₁₀ 500 / 7 - 25.0 - - 1.46 49.5 3.743 33 Pt₂₀CU₁₀ 500 / 7 - 26.4 - - 1.46 49.5 3.765 29 Pt₂₀CU₁₀ 600 / 7 Pt₂₀CU₁₀ 16.0 15.1 780.8 6.06 117.9 3.744 24 Pt₂₀CU₁₀ 600 / 7 - 16.8</td><td>Pt₂₅CU₇₅ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt₂₅CU₇₅ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt₂₅CU₇₅ 600 / 7 - 26.4 - - 1.36 46.3 3.752 29 Pt₂₅CU₇₅ 500 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt₂₅CU₇₅ 500 / 7 - 15.0 - - 1.88 36.4 3.811 15 Pt₂₅CU₇₅ 500 / 7 - 25.0 - - 1.46 49.5 3.743 29 Pt₂₅CU₇₅ 600 / 7 Pt₂₀Cu₇₆ 16.0 15.1 721.5 5.60 108.9 3.729 23 Pt₂₇₅Cu₇₅ 600 / 7 Pt₂₀Cu₆₆ 16.6 - - 4.08 87.2 3.744 24 Pt₂₇₅Cu₇₅ 600 / 7 -</td><td>Pt₂₅CU₁₇ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt₂₅CU₁₇ 600 / 7 - 15.0 - - 1.92 62.0 3.756 27 Pt₂₅CU₁₇ 600 / 7 - 26.4 - - 1.36 46.3 3.756 29 Pt₂₅CU₁₇ 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt₂₅CU₁₇ 500 / 7 - 15.0 - - 1.88 36.4 3.811 15 Pt₂₅CU₁₇ 500 / 7 - 25.0 - - 1.46 49.5 3.765 29 Pt₂₅CU₁₇ 500 / 7 - 26.4 - - 1.46 49.5 3.765 29 Pt₂₇CU₁₇ 600 / 7 Pt₂₀Cu₁₈ 16.0 15.1 78.0 108.9 3.730 23 Pt₂₀Cu₁₇ 600 / 7 - 16.6 -</td><td>Pt₂₅CU₁₀ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt₂₅CU₁₀ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt₂₅CU₁₀ 600 / 7 - 25.0 - - 1.36 46.3 3.752 29 Pt₂₅CU₁₀ 500 / 7 - 14.5 - - 1.88 36.4 3.811 15 Pt₂₅CU₁₀ 500 / 7 - 15.0 - - 1.46 49.5 3.743 33 Pt₂₅CU₁₀ 500 / 7 - 26.4 - - 1.46 49.5 3.743 29 Pt₂₅CU₁₀ 500 / 7 - 26.4 - - 1.46 49.5 3.749 24 Pt₂₅CU₁₀ 600 / 7 Pt₂₅CU₁₀ 16.6 - - 4.08 87.2 3.749 24 Pt₂₅CU₁₀ 600 / 7 - 16.8</td><td>Pt₃CU₇ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt₃CU₇ 600 / 7 - 25.0 - - 1.36 62.0 3.766 27 Pt₃CU₇ 600 / 7 - 26.4 - - 1.36 46.3 3.732 29 Pt₃CU₇ 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt₃CU₇ 500 / 7 - 25.0 - - 1.88 36.4 3.713 15 Pt₃CU₇ 500 / 7 - 25.0 - - 1.46 49.5 3.743 33 Pt₃CU₇ 600 / 7 Pt₃CU₉ 16.0 15.1 721.5 5.60 108.9 3.749 24 Pt₃CU₇ 600 / 7 Pt₃CU₉ 16.6 - - 4.08 87.2 3.744 24 Pt₃CU₇ 600 / 7 Pt₃Cu₉ -</td><td>Place Curron COOT - 15.0 - - 3.83 73.9 3.785 17 Place Curron 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Place Curron 600 / 7 - 25.0 - - 1.36 46.3 3.756 27 Place Curron 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Place Curron 500 / 7 - 14.5 - - 1.88 36.4 3.811 15 Place Curron 500 / 7 - 25.0 - - 1.88 36.4 3.813 16 Place Curron 500 / 7 - 26.4 - - 1.46 49.5 3.743 23 Place Curron 600 / 7 Place Curron 16.0 15.1 721.5 5.60 108.9 3.729 23 Place Curron 600 / 7 Place Curron 1</td></t<>	Pt ₂₀ CU ₁₀ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt ₂₀ CU ₁₀ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt ₂₀ CU ₁₀ 600 / 7 - 26.4 - - 1.36 46.3 3.732 29 Pt ₂₀ CU ₁₀ 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt ₂₀ CU ₁₀ 500 / 7 - 14.5 - - 1.88 36.4 3.811 15 Pt ₂₀ CU ₁₀ 500 / 7 - 25.0 - - 1.46 49.5 3.743 33 Pt ₂₀ CU ₁₀ 500 / 7 - 26.4 - - 1.46 49.5 3.765 29 Pt ₂₀ CU ₁₀ 600 / 7 Pt ₂₀ CU ₁₀ 16.0 15.1 780.8 6.06 117.9 3.744 24 Pt ₂₀ CU ₁₀ 600 / 7 - 16.8	Pt ₂₅ CU ₇₅ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt ₂₅ CU ₇₅ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt ₂₅ CU ₇₅ 600 / 7 - 26.4 - - 1.36 46.3 3.752 29 Pt ₂₅ CU ₇₅ 500 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt ₂₅ CU ₇₅ 500 / 7 - 15.0 - - 1.88 36.4 3.811 15 Pt ₂₅ CU ₇₅ 500 / 7 - 25.0 - - 1.46 49.5 3.743 29 Pt ₂₅ CU ₇₅ 600 / 7 Pt ₂₀ Cu ₇₆ 16.0 15.1 721.5 5.60 108.9 3.729 23 Pt ₂₇₅ Cu ₇₅ 600 / 7 Pt ₂₀ Cu ₆₆ 16.6 - - 4.08 87.2 3.744 24 Pt ₂₇₅ Cu ₇₅ 600 / 7 -	Pt ₂₅ CU ₁₇ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt ₂₅ CU ₁₇ 600 / 7 - 15.0 - - 1.92 62.0 3.756 27 Pt ₂₅ CU ₁₇ 600 / 7 - 26.4 - - 1.36 46.3 3.756 29 Pt ₂₅ CU ₁₇ 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt ₂₅ CU ₁₇ 500 / 7 - 15.0 - - 1.88 36.4 3.811 15 Pt ₂₅ CU ₁₇ 500 / 7 - 25.0 - - 1.46 49.5 3.765 29 Pt ₂₅ CU ₁₇ 500 / 7 - 26.4 - - 1.46 49.5 3.765 29 Pt ₂₇ CU ₁₇ 600 / 7 Pt ₂₀ Cu ₁₈ 16.0 15.1 78.0 108.9 3.730 23 Pt ₂₀ Cu ₁₇ 600 / 7 - 16.6 -	Pt ₂₅ CU ₁₀ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt ₂₅ CU ₁₀ 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Pt ₂₅ CU ₁₀ 600 / 7 - 25.0 - - 1.36 46.3 3.752 29 Pt ₂₅ CU ₁₀ 500 / 7 - 14.5 - - 1.88 36.4 3.811 15 Pt ₂₅ CU ₁₀ 500 / 7 - 15.0 - - 1.46 49.5 3.743 33 Pt ₂₅ CU ₁₀ 500 / 7 - 26.4 - - 1.46 49.5 3.743 29 Pt ₂₅ CU ₁₀ 500 / 7 - 26.4 - - 1.46 49.5 3.749 24 Pt ₂₅ CU ₁₀ 600 / 7 Pt ₂₅ CU ₁₀ 16.6 - - 4.08 87.2 3.749 24 Pt ₂₅ CU ₁₀ 600 / 7 - 16.8	Pt ₃ CU ₇ 600 / 7 - 15.0 - - 3.83 73.9 3.785 17 Pt ₃ CU ₇ 600 / 7 - 25.0 - - 1.36 62.0 3.766 27 Pt ₃ CU ₇ 600 / 7 - 26.4 - - 1.36 46.3 3.732 29 Pt ₃ CU ₇ 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Pt ₃ CU ₇ 500 / 7 - 25.0 - - 1.88 36.4 3.713 15 Pt ₃ CU ₇ 500 / 7 - 25.0 - - 1.46 49.5 3.743 33 Pt ₃ CU ₇ 600 / 7 Pt ₃ CU ₉ 16.0 15.1 721.5 5.60 108.9 3.749 24 Pt ₃ CU ₇ 600 / 7 Pt ₃ CU ₉ 16.6 - - 4.08 87.2 3.744 24 Pt ₃ CU ₇ 600 / 7 Pt ₃ Cu ₉ -	Place Curron COOT - 15.0 - - 3.83 73.9 3.785 17 Place Curron 600 / 7 - 25.0 - - 1.92 62.0 3.756 27 Place Curron 600 / 7 - 25.0 - - 1.36 46.3 3.756 27 Place Curron 600 / 7 - 14.5 - - 2.29 42.9 3.793 16 Place Curron 500 / 7 - 14.5 - - 1.88 36.4 3.811 15 Place Curron 500 / 7 - 25.0 - - 1.88 36.4 3.813 16 Place Curron 500 / 7 - 26.4 - - 1.46 49.5 3.743 23 Place Curron 600 / 7 Place Curron 16.0 15.1 721.5 5.60 108.9 3.729 23 Place Curron 600 / 7 Place Curron 1

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Electro- chemical surface area [cm2]																			1.43
Approx. particle size (Å)	19	29		24	24	24	24		20	24	24	25	24	32	58	25	17	40	83
Lattice parameter (Å)	3.942	3.742	•	3.742	3.746	3.753	3.753	•	3.739	3.811	3.811	3.729	3.752	3.710	3.713	3.757	3.733	3.805	3.710
EDS Corrected Relative Activity at +0.15 V MMS	48.70	4.82	3.91	4.96	4.84	•	•	,	4.25	4.94	6.59		5.15	-	,	•	6.81	4.77	4.15
Catalyst Mass Activity at +0.15 V MMS (mA/mg)	48.70	98.77	82.69	101.67	99.12	96.22	135.71		96.46	111.91	210.95	96.95	96.95	67.41	55.14	131.90	116.66	88.40	119.87
Relative activity at +0.15 V MMS	1.00	4.79	4.01	4.93	4.81	4.67	4.66	•	4.51	5.23	6.98	4.70	4.70	3.10	1.50	3.76	6.20	4.11	5.75
Pt Mass Activity at +0.15 V MMS (mA/mg Pt)	128.82	617.29	516.80	635.46	619.48	601.40	848.18	,	581.10	674.16	1270.78	605.94	605.94	398.88	192.81	484.94	799.02	529.35	741.31
Pt comp. change (%)							,			,		,				,			25
Pt Loading after screening (wt%)		•	•	,	•		,		•			,	,	,		,			18.2
Actual Catalyst Comp. after screening																			Pt52Cu48
Actual Pt Loading before screening (EDS) (wt%) ·	37.8	15.9	16.4	15.9	15.9	,		,	17.6	17.6	17.6	17.2	14.6				13.3	14.4	22.4
Actual Catalyst Comp. before screening	ă	Pt30Cu70	Pt29Cu71	Pt30Cu70	Pt30Cu70				Pt37Cu63	DR37Cu63	Płazcu63	Pt35Cu65	Pt28Cu72				PR31Cu69	Prachings	Pt27Cu73
: Max Alloying Temp for a duration (°C/hrs)	,	600 / 12	600 / 12	600 / 12	600 / 12	600 / 12	600 / 12	600 / 12	/006	1.2	600 / 7	600 / 12	600 / 12	2/009	2/009	2 / 009	600 / 7	600 / 7	950 / 2
Target Pt Loading (wt%)	37.8	16.2	16.2	16.2	16.2	16.2	16.2	16.5	16.6	16.6	2 4	16.2	16.2	16.9	28.6	27.2	446	78.7	16.2
Target Catalyst Comp.	à	PP5C175	PP5C:175	PP5Cu75	PP5Cii75	DP5C175	DPSC175	20000	PESOCATS	02:000	DE30Cit70	PP5Cu75	Pt25Cu75	PP25Cu75	PP5Cu75	PP5Cu75	DINECTE	PIESCUIS DISECTOR	Pt25Cu75
Powder	40	308	300	400	404	5	72,	174	422	3	404	435	436	543	514	545	212	273	917

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			1.20	9		0.29	1.27	1.38			1.29	1.33			1.76	1.02			1.33				1.40				1.33	1.24			1.52	1.52
83	45	69	98	22	72	93	41	45	45	46	္တ	41	छ	22	8	70	33	34	8	ষ্ক	98	49	33	30	22		30	25	25		31	24
3.728	3.804	3.869	3.710	3.734	3.816	3.867	3.711	3.720	3.796	3.867	3.703	3.732	3.791	3.862	3.701	3.720	3.806	3.878	3.689	3.696	3.776	3.859	3.694	3.731	3.785	-	3.702	3.725	3.786	•	3.700	3.745
•	•	•	4.34	2.43	0.58	0.61	5.96	,	•	,	•	,	•	•	6.50		•	,	4.43	,	•	•	4.66		•	-	5.81		•	•	3.47	•
98.63	70.30	36.68	81.04	51.76	13.71	14.60	114.47	105.69	47.53	25.97	95.22	89.95	45.39	25.37	117.14	105.69	68.70	47.25	86.84	85.90	57.14	27.19	93.05	96.39	54.57	,	109.32	98.63	67.14	68.29	67.41	96.39
4.57	3.02	1.51	3.89	2:40	0.59	0.60	5.50	4.90	2.04	1.07	4.57	4.17	1.95	1.05	5.62	4.90	2.95	1.95	4.17	3.98	2.45	1.12	4.47	4.47	2.34	•	5.25	4.57	2.88	2.82	3.24	4.47
588.84	389.05	194.98	501.19	309.03	75.86	77.62	707.95	630.96	263.03	138.04	588.84	537.03	251.19	134.90	724.44	630.96	380.19	251.19	537.03	512.86	316.23	144.54	575.44	575.44	302.00	-	676.08	588.84	371.54	363.08	416.87	575.44
·,			8	18	0	-	33		•	•		•	•	•	33	•	•	•	33	•			33		-	•	44	,	•		37	
18.3	18.6	19.0	17.9	17.9	18.2	18.7	18.4	18.4	18.7	18.9	18.4	18.4	18.5	18.9	18.4	18.5	18.7	19.0	18.5	18.4	18.6	18.9	18.5	18.4	18.8	18.7	18.8	18.6	18.8	18.8	18.7	18.7
Pt55Cu45	Pt67Cu33	Pt84Cu16	Př46Cu54	Ft46Cu54	Pt53Cu47	Pt72Ct28	D#60Cu40	Pf60Cu40	Pt68Cu32	Pt78Cu22	Pt58Cu42	Pt59Cu41	Pt64Cu36	Pt79Cu21	Pt60Cu40	Pt64Cu36	Pt71Cu29	Pt85Cu15	Pt61Cu39	Pt60Cu40	Pt66Cu34	Pt78Cu22	Pf61Cu39	Pt59Cu41	Pt75Cu25	Pt69Cu31	Pt73Cu27	Pt66Cu34	Pt73Cu27	Pf76Cu24	Pt69Cu31	Pt71Cu29
			14.5	16.5	18.2	187	14.0	D		,					14.0	•	•	٠	15.2	•			15.5				14.6				15.1	
•	,		PP26C1174	PP28Cu72	Pf54Cu46	DF74C1120	Pt/ 10029	71200U12					•		Pt27Cu73				Pr28Cu72	,			Pr28Cu72				Pr29Cu71			,	Pt32Cu68	
950 / 2	950 / 2	950 / 2	050 / 10	.050 / 10	950 / 10	050 / 40	2 / 000	2/008	900/2	900/2	900 / 10	900 / 10	900 / 10	900 / 10	800 / 2	800/2	800/2	800/2	800 / 10	800 / 10	800 / 10	800 / 10	7007	700/2	700/2	700/2	700 / 10	700 / 10	700 / 10	700 / 10	600 / 2	600/2
16.8	18.1	18.8	46.5	16.8	18.1	2 0	2.0	76.2	18.1	18.8	16.2	16.8	18.1	18.8	16.2	16.8	18.1	18.8	16.2	16.8	18.1	18.8	16.2	16.8	18.1	18.8	16.2	16.8	18.1	18.8	16.2	16.8
P130Cu70	P150Cu50	DI75C1125	0200011	P123Cu73	DISOCARO	1.00000	Pt/SCu25	Przscu/5	PISOCU50	Pt75Cu25	DP26C117E	Pracu70	Pt50Cu50	Pt75Cu25	PP5Cu75	Pt30Cu70	Pt50Cu50	Pt75Cu25	PISSCATS	Pr30Cu70	Pt50Cu50	PF5C1/25	D1950175	Pt30Cu70	Pt50Cu50	Pt75Cu25	PI25Cu75	Praccu70	Pt50Cu50	Pf75C1125	PP5Cu75	Pt30Cu70
958	657	858	3	200	665	600	999	671	673	674	020	980	681	682	687	88	689	690	805	989	697	809	703	2 2	705	706	711	742	713	7.44	710	720

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		1.52		;				1.00		1.48					1.57		0.76	1.42	1.48	0.95	1.00	1.14	1.33	1.33	1.29	1.10	1.00	0.67	1.10	1.05
23		29	24	24		54	52	70	17	33	35	28	90	62	31	42	90	-	•											
3.812	1	3.699	3.735	3.802	•	3.722	3.742	3.710	3.733	3.694	3.696	3.757	3.783	3.786	3.701	3.707	3.704	-	•	3.701	3.705	3.718	3.723	3.732	3.752	3.765	3.780	3.694	3.702	3.709
-	•	4.22	•	•		•	•	1	•	,	5.00	-	-	1	4.84				3.12	3.51	4.02	4.49	3.88	3.77	3.35	2.14	2.60	3.34	3.39	3.57
64.11	59.48	81.04	85.90	73.61	65.22	87.90	68.06	36.62	106.42	84.86	107.89	53.75	43.02	40.05	100.86	91.97	90.29		73.91	64.16	79.49	93.61	83.82	83.64	75.83	49.11	60.45	60.98	67.14	74.41
2.75	2.45	3.89	3.98	3.16	2.69	4.07	3.07	4.64	5.66	4.07	5.18	1.98	1.24	1.15	4.84	4.27	4.20	5.30	3.55	3.51	4.02	4.49	3.88	3.77	3.35	2.14	2.60	3.34	3.39	3.57
354.81	316.23	501.19	512.86	407.38	346.74	524.65	395.67	597.67	728.90	524.81	667.25	254.72	159.32	147.77	623.77	550.69	540.63	683.03	457.09	452.59	517.62	579.05	500.28	486.20	432.00	275.32	334.52	430.16	437.14	460.30
•	•	35	•	. '		•	•	•	,	٠	28	22	-	-	31	•			11	. 43	45	31	36	53	27	21	23	42	42	28
18.8	18.8	18.5	18.7	18.9	18.8	-	•	1	ı		18.4	18.8		,	18.3	18.3	18.2		18.7	18.4	18.6	18.3	18.6	18.5	18.6	18.6	18.8	18.3	18.5	18.2
Pt77Cu23	Pt75Cu25	Pt64Cu36	Pt69Cu31	Pt79Cu21	Pt75Cu25						Pt58Cu42	Pt77Cu23			Pt56Cu44	Pt56Cu44	Pt53Cu47		Pt70Cu30	Pt58Cu42	Pt65Cu35	Pt56Cu44	Pt66Cu34	Pt64Cu36	Pt67Cu33	Pt66Cu34	Pt73Cu27	Pt57Cu43	Pt62Cu38	Pt53Cu47
-		14.9					,	,		16.4	16.8	18.3	,	,	16.2				18.4	14.2	15.4	16.2	16.8	17.2	17.6	17.8	18.1	14.2	15.4	16.2
,		Pt29Cu71	•	,				-		Pt27Cu73	Pt30Cu70	Pt55Cu45	,		Pt25Cu75	,			Pt59Cu41											
600 / 2	600/2	600 / 10	600 / 10	600 / 10	600 / 10	950 / 10	950 / 10	950 / 10	2 / 009	800/2	800/2	NA	N/A	ΑN	800/3	2/009	900 / 2	2/ 009	,	800/2	800/2	800/2	800 / 2	800/2	800/2	800/2	800/2	900 /	900/	/006
18.1	18.8	16.2	16.8	18.1	18.8	16.8	17.2	16.2	14.6	16.2	16.2	21.1	27.0	27.1	16.2	16.7	16.7	16.2	16.2	14.2	15.4	16.2	16.8	17.2	17.6	17.8	18.1	14.2	15.4	16.2
Pt50Cu50	Pt75Cu25	Pt25Cu75	Pr30Cu70	Pt50Cu50	Pt75Cu25	Pt30Cu70	Pt35Cu65	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt48Cu52	Pt61Cu39	Pt63Cu37	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pr25Cu75	Pt15Cu85	PPZOCII80	Pr25Cu75	Pt30Cu70	Pf35Cu65	Pt40Cu60	Pt45Cu55	Pt50Cu50	Pt15Cu85	Pt20Cu80	PI25Cu75
727	27	7.27	728	729	230	88	85	293	74%	848	026	1072	1073	1074	1077	1120	1121	1202	1206	1866	1867	1868	1869	1870	1871	1872	1873	1874	1875	1876

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	1.10	1.14	1.10	1.00	0.95
			:		
	3.725	3.745	3.768	3.782	3.797
	3.44	2.71	1.88	1.72	1.73
	74.24	59.95	42.62	39.62	40.29
	3.44	2.71	1.88	1.72	1.73
	443.09	348.51	242.83	222.12	222.99
	28	28	27	24	21
	18.4	18.5	18.6	18.7	18.7
	Pt58Cu42	Pt63Cu37	Pt67Cu33	Pt69Cu31	Pt71Cu29
	16.8	17.2	17.6	17.8	18.1
			•		
1.2	900 / 1.2	900 / 1.2	900 /	900 /	900 / 1.2
	16.8	17.2	17.6	17.8	18.1
	Pt30Cu70	Pt35Cu65	Pt40Cu60	Pt45Cu55	Pt50Cu50
_	1877	1878	1879	1880	1881

* Samples 433 and 434 were prepared by co-precipitation. All other samples were prepared by freeze-drying.

^{*} Samples 421 and 434 were screened at 60°C. All other samples were screened at room temperature.

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Example 4 - Evaluation of Catalytic Activity of Supported Catalysts

[0130] The supported alloy catalysts set forth in Table P and Q, and formed according to Example 3, were subjected to electrochemical measurements to evaluate their activities. For the evaluation, the supported
5 catalysts were applied to a rotating disk electrode (RDE) as is commonly used in the art (see, Rotating Disk Electrode Measurements on the CO Tolerance of a High-surface Area Pt/Vulcan Carbon Fuel Cell Electrocatalyst, Schmidt et al., Journal of the Electrochemical Society (1999), 146(4), 1296-1304; and, Characterization of High Surface-Area Electrocatalysts using a Rotating Disk
10 Electrode Configuration, Schmidt et al., Journal of the Electrochemical Society (1998), 145(7), 2354-2358). Rotating disk electrodes are a relatively fast and simple screening tool for evaluating supported catalysts with respect to their intrinsic electrolytic activity for oxygen reduction (e.g., the cathodic reaction of a fuel cell).

[0131] The rotating disk electrodes were prepared by depositing an 15 aqueous-based ink that comprises the support catalyst and a NAFION™ solution on a glassy carbon disk. The concentration of catalyst powder in the NAFION™ solution was about 1 mg/mL. The NAFIONTM solution comprised the perfluorinated ion-exchange resin, lower aliphatic alcohols and water, wherein 20 the concentration of resin was about 5 percent by weight. The NAFION™ solution is commercially available from ALDRICH as product number 27,470-4. The glassy carbon electrodes were 5 mm in diameter and were polished to a mirror finish. Glassy carbon electrodes are commercially available, for example, from Pine Instrument Company of Grove City, Pennsylvania. For each 25 electrode, an aliquot of 10 µL the catalyst suspension was deposited on to the glass carbon disk and allowed to dry at a temperature between about 60 and 70°C. The resulting layer of NAFION™ and catalyst was less than about 0.2 µm thick. This method produced slightly different platinum loadings for each electrode made with a particular suspension, but the variation was determined to 30 be less than about 10 percent by weight.

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[0132] After being dried, each rotating disk electrode was immersed into an electrochemical cell comprising an aqueous 0.5 M H₂SO₄ electrolyte solution maintained at room temperature. Before performing any measurements, the electrochemical cell was purged of oxygen by bubbling argon through the electrolyte for about 20 minutes. All measurements were taken while rotating the electrode at about 2000 rpm, and the measured current densities were normalized either to the glassy carbon substrate area or to the platinum loading on the electrode. Two groups of tests were performed to screen the activity of the supported electrocatalysts. The first group of tests comprised cyclic voltammetric measurements while purging the electrolyte with argon. Specifically, the first group comprised:

- a. two consecutive potential sweeps starting from OCP to about
 +0.35V then to about -0.65V and back to OCP at a rate of about 50 mV/s;
- b. two hundred consecutive potential sweeps starting from OCP to about +0.35V then to about -0.65V and back to OCP at a rate of about 200 mV/s; and
- c. two consecutive potential sweeps starting from OCP to about +0.35V then to about -0.65V and back to OCP at a rate of about 50 mV/s.

The second test comprised purging with oxygen for about 15 minutes followed by a potential sweep test for oxygen reduction while continuing to purge the electrolyte with oxygen. Specifically, potential sweeps from about -0.45 V to +0.35 V were performed at a rate of about -5 mV/s to evaluate the initial activity of the catalyst as a function of potential and to create a geometric current density plot. The catalysts were evaluated by comparing the diffusion corrected activity at 0.15 V. All the foregoing test voltages are with reference to a mercury/mercury sulfate electrode. Also, it is to be noted that the oxygen reduction measurements for a glassy carbon RDE without a catalyst did not show any appreciable activity within the potential window.

[0133] The above-described supported catalyst compositions were evaluated in accordance with the above-described method and the results are set forth in Tables P and Q. It is to be noted from the results presented therein

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that substantially all of the carbon supported catalyst compositions exhibited an oxygen reduction activity which exceeded, for example, the carbon supported platinum standard (see, e.g., samples HFC 363, 369-374, 382-84, 387, 389 and 390 in Table P and samples HFC 434, 516, 687, 711 and 847 in Table Q).

5 [0134] The results of the evaluation indicate, among other things, that a supported catalyst of the present invention may be produced using different method conditions (e.g., temperature and/or duration). It is to be noted, however, that it may take numerous iterations to develop a set of parameters for producing a particular catalyst composition. Also evidenced by the data is that activity may be adjusted by changes in the method conditions.

[0135] Further, without being held to a particular theory, it is presently believed that differences in activity for similar catalyst compositions may be due to several factors, such as homogeneity (e.g., an alloy, as defined herein, may have regions in which the constituent atoms show a presence or lack of order, 15 i.e., regions of solid solution within an ordered lattice, or some type of superstructure), changes in the lattice parameter due to changes in the average size of component atoms, changes in particle size, and changes in crystallographic structure/symmetry. The ramifications of synthesis, structure and symmetry changes are often difficult to predict. For example, while it may 20 be expected that within the Pt-Cu system the two metals will be fully miscible, the possibility exists that ordering may occur between the two metals at the atomic level. The possibility further exists that as the relative ratio of copper to platinum changes, a solid solution may crystallize (e.g., Pt, Cu,), and out of this solid solution an ordered phase may gradually crystallize (e.g., Pt₅₀Cu₅₀), only to 25 return to a solid solution (disordered alloy), and again back to an ordered phase (e.g., Pt₂₅Cu₇₅).

[0136] Symmetry changes (e.g., those associated with the changes from a cubic face centered structure to another structure type, such as a tetragonal or hexagonal structure for example) may result in significant changes in the X-ray diffraction pattern. These changes may also be accompanied by more subtle changes in lattice parameters that may be indicative of the resulting changes in the size of the respective metal constituents. For example, the 12-coordinate metallic radii of platinum and copper are 1.387 Å and 1.278 Å, respectively, and

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as one metal is substituted for another, the average metal radius and, consequently, the observed lattice parameter, may be expected to shrink or expand accordingly. The average radius may be used as an indicator of lattice changes as a function of stoichiometry, or alternatively, as an indicator of 5 stoichiometry based on observed lattice parameters. It should be noted. however, that while average radii may be useful as a general rule, experimental results should be expected to conform only in a general manner because local ordering, significant size disparity between atoms, significant changes in symmetry, and/or other factors may produce values that are inconsistent with 10 expectations. Occasionally, however, the use of alternative metallic radii may be informative. One such alternative radius concept approximates metal radii using known crystallographically ordered Pt-based alloys, such as PtCu (wherein cubic symmetry is maintained), instead of pure metals. (See, e.g., Pearson's Handbook, P. Villars, ed., ASM International, 1997.) In this case, the same 15 close-packed geometric arguments are relevant, with the exception that the lattice parameter of the ordered metal alloy is used in conjunction with the accepted 12-coordinate metallic radius of platinum, supra. Using these concepts, it is believed that the effective radius of copper is about 1.284 Å.

[0137] An interpretation of XRD analyses for a few of the foregoing 20 supported catalysts is set forth below. It is to be noted, however, that interpretation of XRD analyses can be subjective, and therefore, the following conclusions are not intended to be limiting.

[0138] At least a portion of the catalyst powders listed in Tables P and Q were analyzed to determine both the lattice parameter, assuming a 25 face-centered cubic lattice, and the observed particle size (i.e., the size of the metal-containing deposits on the supports). The peak positions were corrected using silicon powder (SRM 640c). The average particle sizes of the catalyst deposits, not of any copper or copper-rich impurity phases, were determined using the Scherrer formula. The term "particle size" as used herein with respect to the size of metal deposits on the supports shall be interpreted as the average particle size. The supported platinum powder used to prepare, with few exceptions (e.g., sample HFC 374-381), the catalyst powders described herein (i.e., the standard supported platinum powder) had a particle size of

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approximately 19 Å. The HFC 374-381 catalysts were prepared with two alternative supported platinum powders. The HFC 374, 375, 378 and 379 were prepared with a first alternative supported platinum powder that consisted of carbon supports as described above with platinum metal deposits having a particle size that is smaller than 19 Å. Specifically, the first alternative powder has a loading of between about 16 and about 18 weight percent, and a particle size of about 12 and about 19 Å. The second alternative powder has a platinum loading of between about 30 and about 35 weight percent.

[0139] All of the catalysts of Table P and Q displayed XRD patterns of a 10 face-centered cubic ("fcc") material, or a fcc-based material. Certain materials displayed slight indications of ordering (see description of the different catalysts below). In general, the observed lattice parameters of the catalyst compositions in Tables P and Q agreed with what was expected for the particular target catalyst compositions. However, in some circumstances, the lattice parameters 15 were larger than what was anticipated, and based on the XRD profile (e.g., the presence of additional peaks or peak shape irregularities) it is believed that this discrepancy is due, at least in part, to the presence of incompletely reacted, or alloyed, copper or copper-rich impurities. For example, referring now to Figure 5, the general background pattern is due to the presence of carbon; peaks A, B, 20 and C are that of a platinum-copper alloy deposits and peaks X, Y, and Z are that of copper and/or copper-rich impurity deposits. The narrower aspect of the copper/copper-rich impurity peaks is due to the fact that the impurity deposits are larger in size than the platinum-copper alloy deposits. Because of the presence of copper or copper-rich impurities, the amount of platinum in the alloy 25 deposits is actually greater than the target composition and this results in a larger observed lattice parameter. Additionally, the results generally indicate that as the copper content in the target stoichiometry increases there is greater tendency to have more unreacted, or unalloyed, copper or copper-rich impurities for syntheses at a given temperature/time.

30 **[0140]** The observed lattice parameters of the Pt₁₆Cu₈₄ catalysts (HFC 360 and 367) are consistent with the amount of copper impurities (i.e., although the global stoichiometry of the supported catalyst may be Pt₁₆Cu₈₄, the presence of the copper impurities results in an empirical stoichiometry of Pt_{16+x}Cu_{84-x} and a

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concomitant increase in the observed lattice parameter). Specifically, the lattice parameters of HFC 360 and 367 are about 3.705 Å and about 3.702 Å, respectively, and the relative performance of HFC 367 is about 18.5% greater than HFC 360. Additionally, the differences in heat treatments resulted in differences in particle sizes; the observed lattice parameters of the Pt₂₀Cu₈₀ catalysts (HFC 361 and 368) are similarly consistent with the amount of copper impurities.

[0141] The observed lattice parameters of the Pt₂₅Cu₇₅ catalysts in Table P (HFC 344, 362, 369, 374, 376, 378, 380, 382 and 387) varied according to the 10 starting supported platinum powder that was used. In general, the alloys prepared from the alternative supported platinum powders (HFC 374, 376, 378 and 380) had larger lattice parameters, and more crystalline copper or copperrich impurities. Accordingly, the electrochemical performance of these materials suffered compared to the materials prepared using the standard supported 15 platinum powder. The observed lattice parameters for alloys prepared using the standard supported platinum powder are consistent with each other and the alloy stoichiometry as measured by EDS. At this time, it is not fully understood why the catalysts produced by the alternative powders were less reacted than those produced with the standard powder. However, it is believed that more 20 complete alloying may be achieved through routine experimentation to determine the optimum values of one or more method parameters, such as alloying temperature and/or duration. Upon determining the optimum values, it is possible that the alternative supported platinum powders, especially the powder having platinum particles of a size less than the standard powder, will 25 result alloy particles that yield greater electrochemical performance due, at least in part, to the smaller particle size.

[0142] The observed lattice parameters of the Pt_{27.5}Cu_{72.5} catalysts (HFC383 and 388) are generally consistent with the stoichiometry as measured by EDS. The differences in particle sizes are also consistent with the synthesis temperatures and seem to contribute to electrochemical performance (i.e., lower synthesis temperatures tend to produce smaller particles that tend to result in greater electrochemical activity than larger particles of the same composition).

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[0143] The observed lattice parameters of the Pt₃₀Cu₇₀ catalysts (HFC 345, 363, 370, 375, 377, 379, 381, 384 and 389) vary according to the starting material used. In general, the alloys prepared from the alternative supported platinum powders (HFC 375, 377, 379 and 381) had larger lattice parameters and more copper or copper-rich impurities. Accordingly, the electrochemical performance of these materials suffered compared to the materials prepared using the standard supported platinum powder. The observed lattice parameters for alloys prepared using the standard supported platinum powder are consistent with each other and the alloy stoichiometry as measured by EDS. 10 Among the alloys prepared using the standard supported platinum powder, those with more copper or copper-rich impurities tend to under-perform electrochemically.

[0144] The observed lattice parameters of the Pt_{32.5}Cu_{67.5} catalysts (HFC 385 and 390) are larger than expected. Specifically, the observed parameters for HFC 854 and 390 are 3.760 and 3.764, respectively, whereas the calculated lattice parameter is 3.725. The observed particle sizes are consistent with the synthesis temperature (i.e., higher synthesis temperatures tend to produce larger the particles).

[0145] The observed lattice parameters of the Pt₃₅Cu₆₅ catalysts (HFC 287, 290, 364, 371, 386 and 391) are generally consistent with the observed copper or copper-rich impurities. The particle sizes increased with increasing synthesis temperatures. The observed electrochemical activity of the 900 °C material was less than that for the 700 °C material. The electrochemical activity of the 700 °C materials is considered to be consistent with stoichiometry. It is believed that the relatively low electrochemical performance of HFC 386 is due to incomplete alloying at the relatively low temperature of 600 °C.

[0146] The Pt₄₀Cu₆₀ catalysts (HFC 346, 365 and 372) seem to be consistent with the general rule that increasing synthesis temperature tend to result in increasing particle size and decreasing electrochemical activity. The 30 lattice parameter of HFC 346 is largest because it had the largest amount of copper and/or copper-rich impurities. This is believed to be a reason why it had a lower activity than the HFC 365 catalyst, which was also prepared at 700 °C.

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[0147] The observed lattice parameter of the $Pt_{45}Cu_{55}$ catalyst (HFC 347) is larger than expected for the stoichiometry because of copper and/or copperrich impurities as previously discussed. The observed particle size is consistent with the synthesis temperature.

5 [0148] In view of the foregoing, for a particular catalyst composition, a determination of the optimum conditions is preferred to produce the highest activity for that particular composition. In fact, for certain catalyst compositions, different structural characteristics may define what exactly is described as a good catalyst. These characteristics may include differences in the composition 10 (as viewed by lattice parameter), crystallinity, crystallographic ordering and/or particle size. These characteristics are not necessarily predictable and may depend on a complex interplay between starting materials, synthesis method, synthesis temperature and composition. For example, the starting materials used to synthesize the catalyst alloy may play a role in the activity of the 15 synthesized catalyst alloy. Specifically, using something other than a metal nitrate salt solution to supply the metal atoms may result in different activities. Additionally, alternative Pt sources may be employed. Freeze-drying and heat treatment parameters such as atmosphere, time, temperature, etc. may also need to be optimized. This optimization may be compositionally dependent. 20 Additionally, this optimization may involve balancing competing phenomena. For example, increasing the heat treatment temperature is generally known to improve the reduction of a metal salt to a metal, which typically increases activity; however, this also tends to increase the size of the catalyst alloy particle and decrease surface area, which decreases electrocatalytic activity.

25 Example 5 - Washing of Catalyst Composition Precursor

[0149] Additional Pt-Cu catalyst compositions (see Tables R1 and R2, infra) were prepared and evaluated for catalytic activity, generally in accordance with the approaches outlined in Examples 3 and 4, respectively (and as further detailed in Tables R1 and R2). However, after initial preparation and prior to testing, these compositions were subjected to one of various washing procedures (as further detailed in Tables R1 and R2, infra), in order to dissolve

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or remove a portion of the copper present therein.

[0150] To illustrate one preferred approach, 100 mg of a catalyst composition precursor (e.g., HFC 1077, Pt₂₅Cu₇₅), was placed into a 20 ml glass vial followed by the slow addition of 15 ml of a 1 M HClO₄ acid solution (added 5 slowly, over a 5 to 10 second period of time, in order to allow sufficient time for the acid to wet the powder). This mixture was placed on a hot plate that had been previously calibrated to raise the temperature of the mixture to 90-95°C (the vial in which the mixture had been placed being capped, but not tightly, so that any boiling which occurred took place without a build-up of pressure 10 therein).

[0151] After 1 hour under these conditions, the mixture was filtered through filter paper, the filtrate having a pale blue color indicating the presence of Cu ions therein. The filtered cake was washed repeatedly with a large excess of water.

15 **[0152]** Following this initial, single wash cycle, the isolated filter cake was placed into a new vial with another 15 ml of 1 M HClO₄ acid solution. After sufficient stirring to break apart the filter cake, the mixture was returned to the hot plate at 90-95°C for 1 hour. The mixture was then filtered and washed with water. The resulting cake was dried at 90°C for 48 hours.

Table R1

																_			P	J 1./	US	400	04/020	JO4 /	
Actual Loading after wash (from EDS) (wt%)	18.27	18.49	18.07	17.98	17.50	17.28	17.25	17.08	16.81	16.82	17.10	16.74	16.49	16.40	15.99	16.03	17.30	16.65	17.34	17.19	17.66	17.02	18.15	17.85	17.97
Actual Catalyst Comp. after washing	Pt55Cu45	Pt62Cu38	Pt50Cu50	Pt48Cu52	Pf39Cu61	Pt36Cu64	Pt36Cu64	Pt33Cu67	Pt31Cu69	Pt31Cu69	Pt34Cu66	Pt30Cu70	Pf28Cu72	Pt27Cu73	Pt24Cu76	Pt24Cu76	Pt36Cu64	Pt29Cu71	Pt37Cu63	Pt35Cu65	Pt42Cu58	Pt33Cu67	Pt52Cu48	Pt45Cu55	Pt48Cu52
Notes					ത	а	В	В	B	а	Ø	Ø	Ø	Ø	а	Ø	ø	а	а	В	В	а	þ	þ	q
Wash gas	ambient	ambient	05	Ą	ambient	ambient	ambient																		
Wash technique	Soak	Soak	Soak	Soak	Centrifuge Sonification	Centrifuge/ Sonification	Centrifuge/ Sonification																		
# of washes	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	-	1	1	-	-	+
Wash time (min)	30	30	30	30	12	12	12	12	7	7	7	7	4	4	4	4	12	12	7	7	4	4	12	12	12
Acid femp.	25	25	25	22	25	25	25	25	25	25	25	25	25	25	25	25	25	25	25	25	25	25	25	25	25
Acid	0.5	-	0.5	0.5	0.5	0.05	-	0.1	0.5	0.05	1	0.1	0.5	0.05	1	0.1	1	0.1	-	0.1	-	0.1	0.5	0.05	1
Acid	H2SO4	CF3SO3H	H2SO4	H2SO4	H2SO4	H2SO4	CF3SO3H	CF3SO3H	H2SO4	H2S04	CF3SO3H	CF3SO3H	H2SO4	H2SO4	CF3SO3H	CF3SO3H	HCIO4	HCIO4	HCIO4	HCIO4	HCIO4	HCIO4	H2S04	H2SO4	СЕЗЅОЗН
Precursor Max Alloying Temp. for a duration (°C/hrs)	600/12	600/12	600/12	600/12	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2
Target Catalyst Comp. before washing	Pf25Cu75	Pf25Cu75	Pf25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	PP5Cu75	Pt25Cu75	PP25Cu75	Pt25Cu75	Pt25Cu75	PP5Cu75	PP5Cu75	PP5C175	Pł25Cu75	Pf25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt25C1175	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75
Powder Precursor Number	435	435	435	435	848	848	848	848	848	848	848	848	848	848	848	848	848	848	848	848	848	848	848	848	848
Powder	566	808	645	646	873	874	875	876	877	878	879	280	88	282	883	884	885	886	282	888	880	890	892	893	894

WU	200	3/0	245	782																					PC	T/I	US2	200	4/0	268	<u> 347</u>		
17.99	17.44		17.89	17.79	17.98	17.56	18.14	18.11	17.17	17.19	18.19	18.01	17.87	17.74	18.12	17.79	18.00	17.49	18.10	18.41	18.30	18.47	18.04	18.25	18.59	18.62	18.41	18.55	18.21	17.95	18.12	18.40	18.32
Pt48Cu52	Pt38Cu62		Pt46Cu54	Pt44Cu56	Pt48Cu52	Pt40Cu60	Pt52Cu48	Pt51Cu49	Pf35Cu65	Pt35Cu65	Pt53Cu47	Pt49Cu51	Pt46Cu54	Pt43Cu57	Pt51Cu49	Pt44Cu56	Pt48Cu52	Pt39Cu61	Pt51Cu49	Pt59Cu41	Pt56Cu44	Pt61Cu39	Pt49Cu51	Pt55Cu45	Pt65Cu35	Pt67Cu33	Pt59Cu41	Pt64Cu36	Pt53Cu47	Pt47Cu53	Pt51Cu49	Pt59Cu41	Pt57Cu43
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ambient	ambient	ambient	ambient	Ar	ambient	ambient	ambient	02	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient	ambient
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25	25	.25	25	25			25	25	25	25	25	25	6	25	8	25	8	25	66	06	25	25	25	25	25	25	25	25	25	25	25	25	06
0.1	0.05	•	-	-			0.5	0.5		0.5	0.5	0.5	0.5	0.5	0.5	5	5	5	5	5	0.5	0.5	5	5	0.5	0.5	5	5	_	1	5	2	1
СЕЗЅОЗН	H2S04	Nafion	HCIO4	HCIO4	Nafion	Nafion	H2S04	H2SO4	Nafion	H2SO4	H2SO4	H2SO4	H2S04	H2S04	H2SO4	H2SO4	H2SO4	H2SO4	H2S04	H2SO4	H2SO4	H2SO4	H2SO4	H2SO4	H2SO4	H2S04	H2S04	H2SO4	HN03	HN03	HN03	HNO3	HCIO4
800/2	800/2	800/2	800/2	800/2	800/2	800/10	600/12	600/12	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2	800/2
Pt25Cu75	Pf25Cu75	PP5Cu75	Pf25Cu75	Pf25Cu75	Pt25Cu75	Pt25Cu75	Pf25Cu75	Pf25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pf25Cu75	Pf25Cu75	Pf25Cu75	Pf25Cu75	Pt25Cu75	Pf25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75	Pf25Cu75	Pt25Cu75	Pt25Cu75	Pt25Cu75							
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895	912	913	919	930	940	941	942	942	968	696	995	906	990	998	666	1000	1001	1002	1003	1012	1013	1014	1015	1016	1029	1030	1031	1032	1057	1058	1059	1060	1061

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 | 18.55

 | 18.47 | 18.55 | 18.63 | 18.74
 | 17.84
 | 18.34
 | 18.30 | 18.49 | 18.57 | 18.68 | 18.68
 | 18.70 | | 18.37 |
| Pt54Cu46 | | Pt54Cu46 | | Pt49Cu51 | Pt59Cu41 | Pt59Cu41 | Pf66Cu34 | Pt47Cu53 | Pt53Cu47 | Pt55Cu45 | Pt54Cu46

 | Pt64Cu36

 | Pt62Cu38 | Pt64Cu36 | Pt68Cu32 | Pt72Cu28
 | Pt45Cu55
 | Pt57Cu43
 | Pt56Cu44 | Pf62Cu38 | Pt65Cu35 | Pt69Cu31 | Pt69Cu31
 | Pt70Cu30 | | Pt58Cu42 |
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 | D420C180
 | P125C175 | Pt30Cu70 | Pf35Cu65 | Pt40Cri60 | Pt45Cu55
 | Pt50Cu50 | Pt25Cu75 | Pt25Cu75 |
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<u>NOTES</u>: a = sample isolated using a 2 minute centrifuge cycle.

b = sample washed using a 1 minute sonication cycle and isolated using a 5 minute centrifuge cycle.

c = sample isolated by filtration and rinsed with propanol.

d = electrochemical wash of the powder was performed.

e = first wash at 90°C, and second at 25°C.

f = first wash performed for 60 minutes, and the second for 20 minutes.

Table R2

											_		P	CI	:/U	S2	00	4/0	26	84	7		
electrochemical surface area [cm2]			1.11	1.14	1.29		1.33		1.29		1.29	1.33	1.52	10, 1	1.40	1.43	1.48	1.48	0.86	100	201	10.1	1.62
Approx. particle size (Å)	•	•	22	26	72	-	28	1	26	24	25	26	36	27	207	52	26	26	25	25	22	97	26
Lattice parameter (Å), uncorrected	3.761	3.763	3.808	3.755	3.751	3.754	3.750	3.750	3.758	3.740	3.745	3 745	3.740	0.740	3.740	3.745	3.750	3.754	3.750	2 784	0.704	3.750	3.741
Actual Relative performance at +0.15 V MMS data	2.76	2.25	2.31	2.98	3.02	3.25	3.29	3.29	3.27	3.81	3.48	3.46	0.40	4.21	4.57	4.33	4.01	3.35	3.18	200	3.04	3.67	4.06
Catalyst Mass Activity at +0.15 V MMS (mA/mq)	64.20	62.44	66.46	85 77	62 29	72.42	73.05	72.36	70.75	82.62	76.63	74.52	74.33	89.48	96.46	89.13	82.71	74.69	68.31	10.00	81.22	81.19	92.46
Relative performance at +0.15 V MMS	3.11	2.58	2.58	3 34	3.26	3.48	3.51	3.47	3.40	3 97	3.68	2.00	3.30	4.30	4.63	4.28	3.97	3.59	3.28	0.20	3.90	3.90	4.44
Pt Mass Activity at +0.15 V MIMS (mA/ mg Pt)	401.26	332.12	332 32	426.70	420.70	447 93	451.85	447.57	437.60	51103	20.17	473.30	461.00	553.44	596.62	551.30	511.56	461.95	422.54	422.31	502.39	502.17	571.88
Pt change in %	١		16	2 -	780	35	22	28	8	2 %	3 8	77	67.	33	30	42	38	3 %	25	င္ပင္	27	22	18
Pt Loading after screening (wt%)		•	406	10.0	70.7	18.7	184	185	18.4	10.7	10.5	18.3	18.4	18.5	18.3	18.6	185	18.5	5.0.7	18.5	18.5	18.4	18.4
Actual Catalyst Comp. after screening			700000	F100Cu34	Pt52Cu46	P107 Cuss	Pf58C1142	Pf61C139	010101	r 10000470	PID/CU45	Pt56Cu44	Pt59Cu41	Pf61Cu39	Pt57Cu43	Pt66Cu34	D462C1138	P1020430	F102CU30	Pt64Cu36	Pt64Cu36	Pt60Cu40	Pt60Cu40
Powder Precursor Number	125	135	157	433	435	848	040	010	010	040	848	848	848	848	848	848	8/8	040	040	848	848	848	848
Powder	222	000	8 3	645	646	8/3	9/4	070	0/0	110	8/8	879	880	881	882	883	200	100	C88	988	887	888	688

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1.52			1.38				1.43	0.52	0.43			2.38					1.81		1.52	1.48					2.00	1.90	1.62	1.52	2.10	2.14			2.00	1.90	1.95
27		,	24	.	27	•	28	22	31	b	1	1	•	31	•	•	31	31	25	29	-	34	29	-	26	25	28	29	23	26	-	-	29	27	25 I
3.732	3.775	3.774	3.784	3.769	3.726	3.706	3.750	3.779	3.699	-	1	•	3.688	3.712	3.754	3.740	3.735	3.728	3.736	3.731	3.735	3.708	3.732	•	3.763	3.763	3.742	3.748	3.777	3.787	3.782	3.782	3.758	3.758	3.767
4.08	1.81	2.87	2.31	2.84	4.54		2.57	1.94	0.61	5.70	3.59	4.05	,	4.96	3.17	3.24	3.24	3.50	2.83	2.89	3.00	3.87	4.27	1	3.81	2.80	2.93	3.42	2.67	2.87	3.14	2.56	3.42	3.22	3.22
89.53	42.32	66.07	53.55	65.86	102.00	•	59.23	44.43	14.02	129.05	83.91	94.41	-	109.87	74.24	75.19	74.64	79.98	60.99	66.31	69.65	87.11	99.46	•	88.68	66.71	67.97	80.50	63.87	68.94	74.53	61.15	80.12	74.43	75.18
4.30	2.03	3.17	2.57	3.16	4.90	1	2.84	2.13	0.67	6.20	4.03	4.53	•	5.28	3.56	3.61	3.58	3.84	3.17	3.18	3.34	4.18	4.78	•	4.32	3.20	3.26	3.87	3.07	3.31	3.58	2.94	3.85	3.57	3.61
553.76	261.76	408.67	331.25	407.36	630.87	•	366.32	274.79	69.98	798.18	519.02	583.92	,	679.60	459.18	465.04	461.67	494.69	408.79	410.12	430.80	538.79	615.19	•	555.95	412.62	420.39	497.91	395.05	426.44	460.98	378.25	495.55	460.40	465.03
28	10	27	24	.23	23			29		15	15	16		31	19	18	14	18	11	17	18	22	14	11	11	3	11	7	r.	6	13	8	6	23	24
ر الا	18.5	18.7	18.7	18.7	18.5			18.8		18.3	18.6	18.6		18.6	18.7	18.6	18.4	18.5	18.5	18.5	18.6	18.5	18.6	18.7	18.6	18.5	18.4	18.5	18.7	18.8	18.7	18.7	18.5	18.7	18.8
D#47.139	Pf62Cu38	Pt72Cu28	Pt72Cu28	Pt71Cu29	Pt61Cu39			Pf73Cu27		Pt55Cu45	Pt67Cu33	Pf67Cu33		Pt66Cu34	Pt72Cu28	Pf67Cu33	Pt60Cu40	Pt61Cu39	Pf62Cu38	Pt61Cu39	Pt66Cu34	Pt61Cu39	Pt65Cu35	Pf70Cu30	Pf67Cu33	Pt64Cu36	Pt60Cu40	Pf62Cu38	Pf70Cu30	Pf76Cu24	Pt72Cu28	Pt72Cu28	Pt62Cu38	Pt70Cu30	Pt75Cu25
ανα	848	848	848	. 848	848	848	848	848	848	695	435	435	848	848	848	026	970	970	026	970	026	026	970	026	026	026	026	970	026	026	970	970	970	970	970
000	897	893	894	895	912	913	938	939	070	941	942	943	968	696	995	900	265	866	666	1000	1001	1002	1003	1012	1013	1014	1015	1016	1020	1030	1031	1032	1057	1058	1059

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1.71							1.71	1.48	1.90	1.62	1.43	1.19	1.14	1.33	1.24	1.00	1.00	0.95	0.95	1.24	1.14	1.10	1.05	1.00	0.90	0.86	0.90		
23	•	•	•			1	28	,	24	25	30																		
3.792	3.744	3.782	ı	1	•		3.738	3.767	3.782	3.777	3.748	3.730	3.738	3.742	3.766	3.778	3.801	3.791	3.813	3.726	3.747	3.749	3.771	3.778	3.797	3.811	3.817		
2.98	1.93	1.79	1		2.74	N/A	3.41	3.16	2.70	2.85	3.85	2.85	2.39	2.60	2.14	2.55	1.68	1.67	2.08	2.46	2.04	2.10	1.94	2.39	1.67	1.38	1.54		2.83
70.54	45.56	42.52	ı	-	64.36	59.93	79.14	74.98	63.89	68.26	88.98	66.81	56.03	66.09	50.95	98.09	40.08	40.17	50.21	56.51	48.07	49.60	46.14	57.23	40.20	33.34	37.36	68.10	67.04
3.39	2.19	2.04		•	3.09	2.88	3.80	3.60	3.07	3.28	4.27	3.66	2.83	2.93	2.36	2.75	1.77	1.75	2.16	3.09	2.43	2.38	2.14	2.58	1.78	1.45	1.60	3.27	3.22
436.28	281.83	263.02	ı	-	398.09	370.67	489.52	463.75	395.18	422.23	550.35	471.28	364.85	377.28	304.12	353.82	228.31	225.24	277.87	398.66	312.99	306.78	275.38	332.69	229.00	186.90	206.73	421.25	414.70
12	5 67	9	0		0		12	9	6	5	11	9	5	10	4	-	2	5	2	6	5	3	5	7	_	4	6		6
187	18.2	186	18.2		18.2		18.5	18.6	18.7	18.7	18.4	18.4	18.4	18.5	18.7	18.5	18.6	18.8	188	18.2	18.5	18.4	18.6	18.5	18.7	18.8	18.9		18.6
047471130	PISACIA6	D165C135	Pt54Cu46		Pt54Cu46		Pf61C139	Pf65Cu35	Pf68Cu32	Pt71Cu29	PF58C1142	Pt59Cu41	Pf60C140	Pf64Cu36	Pf68Cu32	Pf63Cu37	Pf66C134	Pt73Cu27	Pt74C1126	P154C1146	Pf62C1138	Pf59Cu41	Pt67Cu33	PI64Cu36	Pf70Cit30	Pt73Cu27	Pf79Cu21		Pt67Cu33
020	970	970	970	970	070	070	1077	1077	848	848	848	1866	1867	1868	1869	1870	1871	1872	1873	1874	1875	1876	1877	1878	1879	1880	1881	1853	1853
1000	1000	1001	1063	1064	1065	1080	1070	000	1183	1184	1185	1882	1883	1887	1885	1886	1007	1886	2000	1800	180	1802	1803	1804	1805	1896	1897	1902	1903

[0153] Generally speaking, it is to be noted from the data presented above that, surprisingly, it appears the washing procedure described herein does not necessarily always increase the surface area of the catalyst compositions. This relationship is independent of the annealing temperature of the catalyst. Without being held to any particular theory, it is believed that this may be due to the fact that a more traditional skeleton catalyst, such as that reported for example in U.S. Patent No. 5,876,687, is not being formed here, or is not being formed in the same manner, perhaps due at least in part to the presence of oxygen here. This theory is supported by the relationship of measured composition after washing and measured lattice parameters. Particle size appears to decrease upon washing, however, perhaps indicative of some collapse of the skeleton framework due to the presence of oxygen.

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[0154] It is to be understood that the above description is intended to be illustrative and not restrictive. Many embodiments will be apparent to those of skill in the art upon reading the above description. The scope of the invention should therefore be determined not with reference to the above description alone, but should be determined with reference to the claims and the full scope of equivalents to which such claims are entitled.

[0155] When introducing elements of the present invention or an embodiment thereof, the articles "a", "an", "the" and "said" are intended to mean that there are one or more of the elements. The terms "comprising", "including" and "having" are intended to be inclusive and mean that there may be additional elements other than the listed elements.

25 **[0156]** The recitation of numerical ranges by endpoints includes all numbers subsumed within that range. For example, a range described as being between 1 and 5 includes 1, 1.6, 2, 2.8, 3, 3.2, 4, 4.75, and 5.